# RENESAS

# DATASHEET

# ISL91302B

Dual/Single Output Power Management IC

The <u>ISL91302B</u> is a highly efficient, dual or single output, synchronous multiphase buck switching regulator that can deliver up to 5A per phase continuous output current. The ISL91302B features four integrated power stages and two controllers. The ISL91302B can assign its power stages and controllers to two dual-phase outputs (2+2) or one three-phase and one-phase output (3+1) or one four-phase output (4+0). This flexibility allows seamless design-in for a wide range of applications in which dual, triple, or quad phase outputs are needed, such as CPU and GPU core power mobile applications.

The ISL91302B integrated low ON-resistance MOSFETs, programmable PWM frequency, and automatic diode emulation, which maximizes efficiency while minimizing the external component count and solution size.

The ISL91302B uses the proprietary Renesas R5 modulator technology to deliver a highly robust power solution capable of ultra-fast transient response, excellent loop stability, and seamless DCM/CCM transitions without requiring external compensation.

The ISL91302B is widely configurable through the factory OTP settings. Available features include:

- SPI and I<sup>2</sup>C interface
- External signal telemetry with an internal ADC
- Dynamic Voltage Scaling (DVS) with selectable slew rate

Contact Renesas support for additional configurations.

### Features

- Dual output 3+1 or 2+2, or single output 4-phase
- 2.5V to 5.5V supply voltage
- 5A per phase output current capability
- Small solution size
- High efficiency (94.7% peak for 3.8V  $V_{IN}$ , 1.8V  $V_{OUT}$ , L = 470nH)
- Low I<sub>O</sub> in low power mode
- Proprietary control scheme reduces the output capacitor and supports fast load transients (such as 50A/µs per phase)
- Voltage, current, and temperature telemetry through integrated ADC plus auxiliary inputs
- $\pm 0.7\%$  system accuracy with remote voltage sensing
- OTP programmable PWM frequency from 2MHz to 6MHz
- I<sup>2</sup>C and SPI programmable output from 0.3V to 2.0V
- Independent Dynamic Voltage Scaling (DVS) for each output
- Soft-start and fault detection (UV, OV, OC, OT), short-circuit protection
- 2.551mmx 3.670mm 54 ball WLCSP with 0.4mm pin pitch

### Applications

- Smart phones and tablets
- FPGA and ASIC power
- Industrial MPU power
- Human machine interface





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#### ISL91302B

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# 1. Overview

# 1.1 Typical Application Circuits



Figure 2. Typical Application 4-Phase Single Output









Figure 4. Typical Application Circuit: 2-Phase + 2-Phase



# 1.2 Block Diagram



Figure 5. Block Diagram



# 1.3 Ordering Information

Part Number ( <u>Notes 1</u> , <u>3, 4</u> )	Part Marking	Package Description (RoHS Compliant)	Pkg. Dwg. #	Carrier Type ( <u>Note 2</u> )	Temp Range		
ISL91302BIIZ-T	91302B 2.551mmx3.670mm, 54 Ball 6x9 WLCSF		W6x9.54	Reel, 3k	-40 to +85°C		
ISL91302B22-EVZ	ISL91302B - E	ISL91302B - Evaluation board 1, 2+2 PMIC, WLCSP RoHS compliant					
ISL91302B31-EVZ	ISL91302B - E	ISL91302B - Evaluation board 1, 3+1 PMIC, WLCSP RoHS compliant					
ISL91302B40-EVZ	ISL91302B - E	SL91302B - Evaluation board 1, 4+0 PMIC, WLCSP RoHS compliant					

Notes:

1. For additional part options contact your local sales office.

2. See <u>TB347</u> for details about reel specifications.

3. These Pb-free WLCSP packaged products employ special Pb-free material sets; molding compounds/die attach materials and SnAgCu - e6 solder ball terminals, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Pb-free WLCSP packaged products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J-STD-020.

4. For Moisture Sensitivity Level (MSL), see the ISL91302B device page. For more information about MSL, see TB363.

Part Number	Pin Configuration	Pitch	Output Configuration	Maximum Load
ISL91302B	54 Ball 6x9 WLCSP	0.4mm	Single Output (4 + 0 Phase)	5A
	54 Ball 6x9 WLCSP	0.4mm	Dual Output (3 + 1 Phase)	5A
	54 Ball 6x9 WLCSP	0.4mm	Dual Output (2 + 2 Phase)	5A
ISL91301A	42 Ball 6x7 WLCSP	0.4mm	Triple Output (2+1+1 Phase)	4A
ISL91301B	42 Ball 6x7 WLCSP	0.4mm	Quad Output (1+1+1+1 Phase)	4A
ISL91211A	54 Ball 6x9 WLCSP	0.4mm	Triple Output (2+1+1 Phase)	5A
ISL91211B	54 Ball 6x9 WLCSP	0.4mm	Quad Output (1+1+1+1 Phase)	5A

Table 1. Key Differences Between Family of Parts



# 1.4 Pin Configuration



54 Bump 6x9 WLCSP



# 1.5 Pin Descriptions

Pin Number	Pin Name	Туре	Description
A1, B1	PVIN_A	Input	Power supply for Power Stage A.
A2, B2, C2	PH_A	Output	Switching node for Power Stage A.
A3, B3, C3	PGND_A	Input	Ground connection for Power Stage A.
A4, B4, C4	PGND_B	Input	Ground connection for Power Stage B.
A5, B5, C5	PH_B	Input	Switching node for Power Stage B.
A6, B6	PVIN_B	Input	Power supply for Power Stage B.
C1	GPIO0	Input/Output	General purpose I/O pin, see <u>Table 2</u> .
C6	WDOG_RST	Input	Digital input, resets the bucks to default output voltage.
D1	EN	Input	Master chip enable input, NMOS logic threshold.
D2	GPIO1	Input/Output	General purpose I/O pin, see <u>Table 2</u> .
D3	INT	Output	Interrupt line.
D4, D5, E2, E3, E4, E5	GND	Input	Analog chip ground. Ensure a low impedance connection to the internal ground layer.
D6	RTN1	Input	Remote ground voltage sense for Buck #1.
E1	VOUT2	Input	Remote output voltage sense for Buck #2.
E6	VOUT1	Input	Remote output voltage sense for Buck #1.
F1	RTN2	Input	Remote ground voltage sense for Buck #2.
F2	AVIN_FILT	Output	Filtered analog supply voltage, 2.5 to 5.5V. Place a decoupling capacitor close to the IC.
F3	VIO	Input	I/O supply voltage for digital communications. Normally connected to 1.8V supply.
F4	MPIO0	Input/Output	Multipurpose I/O, see <u>Table 2</u> .
F5	MPIO1		
F6	MPIO2		
G1	AVIN	Input	Analog supply voltage, 2.5V to 5.5V.
G2, H2, J2	PH_C	Output	Switching node for Power Stage C.
G3, H3, J3	PGND_C	Input	Ground connection for Power Stage C.
G4, H4, J4	PGND_D	Input	Ground connection for Power Stage D.
G5, H5, J5	PH_D	Output	Switching node for Power Stage D.
G6	MPIO3	Input/Output	Multipurpose I/O, see <u>Table 2</u> .
H1, J1	PVIN_C	Input	Power supply connection for Power Stage C.
H6, J6	PVIN_D	Input	Power supply connection for Power Stage D.

#### Table 2. I/O Pin Configuration

IO_PINMODE	MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1	Description
0x0	SCK	SS_B	MOSI	MISO	SCL	SDA	I <sup>2</sup> C/SPI both available
0x1	SCK	SS_B	MOSI	MISO	EN_A	EN_B	SPI mode with hardware buck enable pins
0x2	Reserved						
0x3	SCK	SS_B	MOSI	MISO	DVS1_0	DVS2_0	SPI with hardware DVS pins
0x4	DVS_PIN1	DVS_PIN0	PGOOD1	PGOOD2	SCL	SDA	I <sup>2</sup> C with global DVS mode with PGOOD1 and PGOOD2



IO_PINMODE	MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1	Description
0x5	DVS1_0	DVS1_1	DVS2_0	DVS2_1	SCL	SDA	I <sup>2</sup> C with full pin controlled DVS for Buck1 and Buck2
0x6	DVS1_0	DVS2_0	PGOOD1	PGOOD2	SCL	SDA	I <sup>2</sup> C with DVS and PGOOD for Buck1 and Buck2
0x7- 0xC	Reserved						
0xD	ADC_IN0	ADC_IN1	PGOOD1	PGOOD2	SCL	SDA	I <sup>2</sup> C with ADC input and PGOOD for Buck1 and Buck2
0xE	ADC_IN0	ADC_IN1	DVS_PIN1	DVS_PIN0	SCL	SDA	I <sup>2</sup> C with ADC input and global DVS
0xF	Reserved						

#### Table 2. I/O Pin Configuration (Continued)

#### Table 3. Pin Mode Name Description

Name	Definition
SCK	SPI clock.
SS_B	SPI slave select (must be pulled to VIO when using I <sup>2</sup> C in Pin Mode 0x0)
MOSI	SPI master out slave in.
MISO	SPI master in slave out.
SCL	I <sup>2</sup> C clock.
SDA	I <sup>2</sup> C data.
PGOOD1, PGOOD2	Power-good output pins.
EN_A, EN_B	Buck enable input pins.
DVS_PIN1, DVS_PIN0	Global DVS logic pins which references a look-up table to allow complete DVS control.
DVS1_0, DVS1_1	DVS input logic pins for Buck1.
DVS2_0, DVS2_1	DVS input logic pins for Buck2.
ADC_IN0, ADC_IN1	Input pins for auxiliary ADC.



# 2. Specifications

# 2.1 Absolute Maximum Ratings

Parameter	Minimum	Maximum	Unit
PVIN and AVIN Pins to PGND	-0.3	+6	V
VOUT Pin BUCKx_VOUTFBDIV = 0x0	-0.3	+2.0	V
VOUT Pin BUCKx_VOUTFBDIV = 0x1	-0.3	+2.4	V
VOUT Pin BUCKx_VOUTFBDIV = 0x2	-0.3	+3.0	V
PH to PGND	-0.3	+0.3 + PVIN	V
VIO, EN Pins to GND	-0.3	+0.3 + AVIN	V
RTN, GND to PGND Pins	-0.3	+0.3	V
INT, WDOG_RST, MPIO, GPIO pins to GND	-0.3	+0.3 + VIO	V
ESD Ratings ( <u>Note 5</u> )	N 1	/alue	Unit
Human Body Model (Tested per JS-001-2014)		2	kV
Charged Device Model (Tested per JS-002-2014)		750	V
Latch-Up (Tested per JESD78E; Class 2, Level A)		100	mA

Note:

5. ESD ratings apply to external pins only.

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions can adversely impact product reliability and result in failures not covered by warranty.

# 2.2 Thermal Information

Thermal Resistance (Typical)	θ <sub>JA</sub> (°C/W)	⊕ <sub>JC</sub> (°C/W)
54 Ball WLCSP Package ( <u>Notes 6</u> , <u>7</u> )	42	0.5

Notes:

 θ<sub>JA</sub> is measured in free air with the component mounted on a high-effective thermal conductivity test board with "direct attach" features. See <u>TB379</u>.

7. For  $\theta_{JC},$  the "case temp" location is taken at the package top center.

Parameter	Minimum	Maximum	Unit
Maximum Junction Temperature (T <sub>J</sub> )		+150	°C
Storage Temperature Range (T <sub>S</sub> )	-65	+150	°C
Pb-Free Reflow Profile		see <u>TB493</u>	

# 2.3 Recommended Operation Conditions

Parameter	Minimum	Maximum	Unit
Ambient Operating Temperature Range (T <sub>A</sub> )	-40	+85	°C
Operating Junction Temperature (T <sub>J</sub> )	-40	+125	°C
Supply Voltage			
AVIN to GND	2.5	5.5	V
PVIN to PGND	2.5	5.5	V
VIO Voltage (VIO to GND)	1.7	AVIN	V
INT, WDOG_RST, MPIO, GPIO Pins to GND	0	VIO	V



# 2.4 Analog Specifications

 $AVIN/PVIN = 3.7V, V_{OUT} = 1V, L = 220nH, Frequency = 4MHz, VIO = 1.8V, T_A = +25^{\circ}C.$  Boldface limits apply across the ambient operating temperature range, -40°C to +85°C unless otherwise noted.

Parameter	Symbol	Test Conditions	Min ( <u>Note 8</u> )	Тур	Max ( <u>Note 8</u> )	Unit
Input Supply						
Supply Voltage	AVIN		2.5		5.5	V
Supply Voltage	PVIN		2.5		5.5	V
AVIN Supply Current	ا <sub>م</sub>	EN = 0V		0.1	1	μA
AVIN + PVIN Supply Current		EN = 0V		<1	6	μA
AVIN + PVIN Supply Current		BUCK1_EN[0] = 0x0 and BUCK2_EN[0] = 0x0		22		μA
EN = AVIN = PVINx = 3.7V		4+0 OTP configuration, not switching BUCK1_EN[0] = 0x1 DCM operation BUCK2_EN[0] = 0x0		75		μA
		4+0 OTP configuration, not switching BUCK1_EN[0] = 0x1 1PH CCM operation BUCK2_EN[0] = 0x0		635		μA
		4+0 OTP configuration, not switching BUCK1_EN[0] = 0x1 4PH CCM operation BUCK2_EN[0] = 0x0		765		μA
		2+2 OTP configuration, not switching BUCK1_EN[0] = 0x0 BUCK2_EN[0] = 0x1 DCM operation		85		μA
		2+2 OTP configuration, not switching BUCK1_EN[0] = 0x0 BUCK2_EN[0] = 0x1 1PH CCM operation		485		μA
		2+2 OTP configuration, not switching BUCK1_EN[0] = 0x0 BUCK2_EN[0] = 0x1 2PH CCM operation		560		μA
UVLO Rising Threshold	V <sub>UVLOR</sub>	Rising	2.52	2.60	2.67	V
UVLO Falling Threshold	V <sub>UVLOF</sub>	Falling	2.28	2.34	2.40	V
Buck Regulation	I					
Buck Output Voltage Range	V <sub>OUT</sub>	BUCKx_VOUTFBDIV[1:0] = 0x00	0.300		1.2	V
(Each Output)		BUCKx_VOUTFBDIV[1:0] = 0x01	0.375		1.5	V
		BUCKx_VOUTFBDIV[1:0] = 0x02	0.500		2.0	V
Output Voltage Step Size	V <sub>STEP</sub>	10-bit control, BUCKx_VOUTFBDIV[1:0] = 0x00		1.2		mV
		10-bit control, BUCKx_VOUTFBDIV[1:0] = 0x01		1.5		mV
		10-bit control, BUCKx_VOUTFBDIV[1:0] = 0x02		2.0		mV
Output Voltage Accuracy	V <sub>ACC</sub>	CCM, V <sub>OUT</sub> > 0.6V	-0.3		0.3	%
(Note 9)		CCM, V <sub>OUT</sub> > 0.6V T <sub>A</sub> = -10°C to +85°C	-0.7		0.7	%
		CCM, V <sub>OUT</sub> < 0.6V	-4		4	mV
		CCM, V <sub>OUT</sub> < 0.6V T <sub>A</sub> = -10°C to +85°C	-5.5		5.5	mV
Current Matching	I <sub>MATCH</sub>	I <sub>OUT</sub> = 5A per phase		10		%
Dynamic Response	•	· · · · · · · · · · · · · · · · · · ·		<u> </u>		
Dynamic Voltage Scaling (Output Slew Rate)	V <sub>DVS</sub>	2.5V < V <sub>IN</sub> < 5.5V: 3mV/µs	-15		15	%



 $AVIN/PVIN = 3.7V, V_{OUT} = 1V, L = 220nH, Frequency = 4MHz, VIO = 1.8V, T_A = +25^{\circ}C.$  Boldface limits apply across the ambient operating temperature range, -40°C to +85°C unless otherwise noted. (Continued)

Parameter	Symbol	Test Conditions	Min ( <u>Note 8</u> )	Тур	Max ( <u>Note 8</u> )	Unit
Boot-Up Time	V <sub>BT</sub>	Delay from when PVIN, AVIN, and EN are asserted to when the first Buck's reference starts ramping. This time includes internal reference startup, OTP load, and buck controller calibration time. BUCKx_EN_DELAY = 0x00		1.4		ms
Frequency						
CCM Frequency Tolerance	f <sub>SW_TOL</sub>	4MHz	-15		15	%
Power Stage						
Buck Output Current (Each Phase)		2.5V < V <sub>IN</sub> < 5.5V			5	A
High-Side Switch ON-Resistance	HS r <sub>DS(ON)</sub>	Conditions: PVIN = 3.7V, current = 300mA		23		mΩ
Low-Side Switch ON-Resistance	LS r <sub>DS(ON)</sub>	Conditions: PVIN = 3.7V, current = 300mA		9		mΩ
Protection						
HSD Current Limit (WOC)	I <sub>LIMIT</sub>	2.5V < V <sub>IN</sub> < 5.5V Phase count = 2 or more; WOC = 11.35A	-10		10	%
		2.5V < V <sub>IN</sub> < 5.5V Phase count = 1; WOC = 8.38A	-10		10	
Thermal Shutdown Accuracy	T <sub>SPS</sub>	2.5V < V <sub>IN</sub> < 5.5V, factory default = +140°C	-10		10	%
Thermal Shutdown Hysteresis	T <sub>SPS_HYS</sub>	2.5V < V <sub>IN</sub> < 5.5V, factory default = +60°C	-10		10	%
Thermal Warning Alert	T <sub>ALERT</sub>	2.5V < V <sub>IN</sub> < 5.5V, factory default = +85°C	-10		10	%
Thermal Warning Hysteresis	T <sub>ALERT_HYS</sub>	2.5V < V <sub>IN</sub> < 5.5V, factory default = +12°C	-10		10	%
Output OVP Threshold Accuracy	V <sub>OVP</sub>	Threshold: +250mV	-35		35	mV
Output UVP Threshold Accuracy	V <sub>UVP</sub>	Threshold: -250mV	-35		35	mV
ADC						
Output Current Sense Offset	I <sub>SENSE_OFFSET</sub>		-75		75	mA
Output Current Sense	I <sub>SENSE_ADC</sub>	I <sub>LOAD</sub> = 500mA (minus offset)	-10		10	%
Accuracy		$3.0V < V_{IN} < 5.0V I_{LOAD} = 500mA (minus offset)$	-15		15	%
MPIO/GPIO Operating Condition	ions					
Allowable Range of Supply for Operation	VIO		1.70	1.80	AVIN	V
Chip Enable Logic Threshold	Level					
Low-Level Input Voltage	V <sub>IL</sub>				0.5	V
High-Level Input Voltage	V <sub>IH</sub>		1.35			V
Serial Interfaces	•	·			•	-
I <sup>2</sup> C Frequency Capability	f <sub>I2C</sub>				3.4	MHz
SPI Frequency Capability	f <sub>SPI</sub>			26		MHz
MPIO/GPIO Logic Threshold I	_evels					•
Low Level Input Voltage	V <sub>IL</sub>				0.25 x VIO	V
High Level Input Voltage	V <sub>IH</sub>		0.75 x VIO			V



 $AVIN/PVIN = 3.7V, V_{OUT} = 1V, L = 220nH, Frequency = 4MHz, VIO = 1.8V, T_A = +25^{\circ}C.$  Boldface limits apply across the ambient operating temperature range, -40°C to +85°C unless otherwise noted. (Continued)

Parameter	Symbol	Test Conditions	Min ( <u>Note 8</u> )	Тур	Max ( <u>Note 8</u> )	Unit
Hysteresis on Input	V <sub>HYS</sub>		0.1 x VIO			V
Low Level Output	V <sub>OL</sub>	1mA			0.4	V
High Level Output	V <sub>OH</sub>	1mA (250µA for 20% drive configuration)	VIO - 0.4			V

Notes:

8. Compliance to datasheet limits is assured by one or more methods: production test, characterization, and/or design.

V<sub>OUT</sub> feedback divider ratio equals 1 (BUCKx\_VOUTFBDIV[1:0] = 0x00).
 As per <u>"Thermal Information" on page 11</u>, operating beyond thermal limits can cause permanent damage.



# 3. Output Configurations

Output Configuration	Power Stage Assignment	Diagram
4-Phase	4-Phase: Buck #1 (VOUT1)	4+0 Configuration
4-Phase Connect VOUT2 and RTN2 to PGND Plane		4+0 Configuration

### Table 4. Output Configurations

Output Configuration	Power Stage Assignment		Diagran	n			
3-Phase + 1-Phase	3+1 Configuration: • 3-phase: Buck #1 (VOUT1) Ph1: PH_A		3+1 Configuration				
	<ul> <li>3-phase: Buck #1</li> </ul>		$(PVIN_A) (PH_A) (PGND_A)$ $(PVIN_A) (PH_A) (PGND_A)$ $(GPIOD) (PH_A) (PGND_A)$ $(GPIOD) (PH_A) (PGND_A)$ $(EN) (GPIOI) (INT)$ $(VOUT2) (GND) (GND)$ $(VOUT2) (GND) (GND)$ $(RTN2) (AVIN_A) (PH_C) (PGND_A)$ $(AVIN_A) (PH_C) (PGND_A)$ $(AVIN_A) (PH_C) (PGND_A)$ $(PVIN_C) (PH_C) (PGND_A)$ $(PVIN_C) (PH_C) (PGND_A)$	$\begin{pmatrix} PGND_{-} \\ B \end{pmatrix} \begin{pmatrix} PH \\ B \end{pmatrix} \begin{pmatrix} PH \\ B \end{pmatrix} \begin{pmatrix} PVIN \\ B \end{pmatrix} \begin{pmatrix} PH \\ B \end{pmatrix} \begin{pmatrix} PVIN \\ B \end{pmatrix} \begin{pmatrix} PH \\ B \end{pmatrix} \begin{pmatrix} PH \\ B \end{pmatrix} \begin{pmatrix} PVIN \\ B \end{pmatrix} \begin{pmatrix} PH \\ PH \end{pmatrix} \begin{pmatrix} PH \\ PH$			
		8 PH2 8 PH		В РНЗ			

#### Table 4. Output Configurations (Continued)

Output Configuration	Power Stage Assignment	Diagram					
2-Phase + 2-Phase	2+2 Configuration • 2-phase: Buck #1	2+2 Configuration					
		2+2 Configuration					

#### Table 4. Output Configurations (Continued)

# 4. Typical Operating Performance

Unless otherwise noted, operating conditions are:  $V_{IN}$  = 3.8V,  $V_{OUT}$  = 1.1V, VIO and Enable = 1.8V,  $T_A$  = +25°C,  $f_{SW}$  = 4MHz, 2-phase operation, L = 220nH,  $C_{OUT}$  = 5x22µF + 8x4.3µF.



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#### ISL91302B

Unless otherwise noted, operating conditions are:  $V_{IN} = 3.8V$ ,  $V_{OUT} = 1.1V$ , VIO and Enable = 1.8V,  $T_A = +25^{\circ}C$ ,  $f_{SW} = 4MHz$ , 2-phase operation, L = 220nH,  $C_{OUT} = 5x22\mu$ F + 8x4.3 $\mu$ F. (Continued)



Figure 12. 2-Phase  $V_{OUT}$  vs  $V_{IN}$  (10mA to 10A)







Figure 13. Single-Phase  $V_{OUT}$  vs  $V_{IN}$  (10mA to 5A)



Figure 15. PVIN Quiescent Current (PWM Mode)



Figure 16. PVIN Quiescent Current (No Switching)



#### ISL91302B

Unless otherwise noted, operating conditions are:  $V_{IN}$  = 3.8V,  $V_{OUT}$  = 1.1V, VIO and Enable = 1.8V,  $T_A$  = +25°C,  $f_{SW}$  = 4MHz, 2-phase operation, L = 220nH,  $C_{OUT}$  = 5x22µF + 8x4.3µF. (Continued)



Figure 17. 0.5V to 1.1V DVS; Load = 5A, Slew Rate = 3mV/µs



Figure 18. 1.1V to 0.5V DVS; Load = 5A, Slew Rate = 3mV/µs







Figure 20. Dual-Phase Transient, C<sub>OUT</sub> =  $9x22\mu$ F and L = 220nH/Phase



# 5. Applications Information

# 5.1 Inductor Selection

The ISL91302B is a high efficiency, high performance, dual output multiphase/single-phase synchronous buck converter that can deliver up to 5A of continuous current per phase at 0.3V to 2.0V regulated voltage from a single Li-Ion battery to power portable and handheld devices. The ISL91302B is designed to provide one or two output voltage rails with operational modes setup to 4+0, 3+1, and 2+2 at a nominal switching frequency of 2MHz~4MHz. Contact <u>support</u> for questions relating to switching frequency of 6MHz. Switching MOSFETs are fully integrated and no additional external MOSFETs or diodes are needed. Each phase requires an equal external inductor that can deliver the maximum load current divided by the number of phases used.

Manufacturer	Part Number	L x W x H (mm)	Value (nH)	DCR mΩ (Typ)	I <sub>SAT</sub> (Тур)
Cyntec	HMLB25201T	2.5x2.0x1.0	220	9.4	7.0
Taiyo Yuden	MAKK2520HR22M	2.5x2.0x1.0	220	16	8.5
Cyntec	HTTN2016T	2.0x1.6x1.0	220	13	7.2
Murata	DFE2016E	2.0x1.6x1.0	240	16	7.0
Murata	DFE252012F	2.5x2.0x1.2	470	23	6.7

Table 5. Recommended Output Inductors

# 5.2 Output Capacitor Selection

Output capacitors are needed to provide filtering of square voltage at the phase node into a regulated output voltage. The amount of output capacitance required is based on the parameters of the maximum load step, the slew rate of the load step, and the maximum allowable voltage regulation tolerance during the transient. The amount of ripple voltage at the output capacitor is also a design constraint; the total peak-to-peak ripple voltages produced from the output capacitor is equal to its ESR multiplied by the worst case inductor ripple current.

Make sure to select X7R or X5R type capacitors and consider for DC bias effects. A wide range of output capacitor values can be used.

Manufacturer	Part Number	Case Size	Value (µF)	Voltage Rating (V)
TDK	C1608X5R1A226M080AC	0603	22	10
TDK	C0510X6S0G105M030AC	0204	1	4
Murata	LLD154R60G435ME01	0402	4.3	4
Murata	LLL1U4R60G435ME22	0204	4.3	4

 Table 6. Recommended Output Capacitors

# 5.3 Input Capacitor Selection

Ceramic input capacitors source the AC component of the input current flowing into the high-side MOSFETs. Place them as close to the IC as possible. If long wires are used to bring power to the IC, use additional bulk capacitors between  $C_{IN}$  and the battery/power supply to dampen ringing and overshoot at startup.

Internal analog reference circuits also require additional filtering at the AVIN\_FLTR pin. A 10 $\mu$ F local decoupling capacitor is recommended for each phase on PVIN.

Manufacturer	Part Number	Case Size	Value (µF)	Volt (V)	Input
TDK Corp	CGB2A1X5R1A105M033BC	0402	1	10	AVIN
Kemet	C0402C104K8RACTU	0402	0.1	10	AVIN
Samsung	CL05A10MP5NUNC	0402	10	10	PVIN
Murata	GRM188R61A106MAAL	0603	10	10	PVIN

Table 7. Recommended	Input	Capacitors
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### 5.4 ADC Telemetry

The device features a 12-bit (effective) SAR ADC telemetry function that supports internal silicon temperature, individual phase current, total buck output current, output voltage, and input voltage measurements. Two additional channels provide additional internal or external monitoring. Using these channels requires OTP programming from the factory. The ADC is OTP programmed to be turned off during Discontinuous Conduction mode to save current and improve light-load efficiency. The ADC supports two operating modes: Continuous Mode, and Non-continuous (or Single-shot or One-shot) Mode.

The telemetry uses a 16-bit output data format (S13.2). It consists of 1-bit sign and 15-bit data. The two LSB bits represent fractional data (after the decimal point). Reading the ADC output is accomplished by reading the respective MSB (8-bit) and LSB (8-bit). <u>Table 8</u> shows the registers that hold the ADC data. See <u>"Register Description by Address" on page 42</u> for more information.

ADC Channel	Register Name	Register Address (hex): ADC MSB Data	Register Address (hex): ADC LSB Data	
Temperature	ADC_SAMPLE0MSB/LSB	0x16	0x17	
Buck1 Ph1 Current	ADC_SAMPLE1PH1MSB/LSB	0x18	0x19	
Buck1 Ph2 Current	ADC_SAMPLE1PH2MSB/LSB	0x1A	0x1B	
Buck1 Ph3 Current	ADC_SAMPLE1PH3MSB/LSB	0x1C	0x1D	
Buck1 Ph4 Current	ADC_SAMPLE1PH4MSB/LSB	0x1E	0x1F	
Buck1 Total Current	ADC_SAMPLE1TMSB/LSB	0x20	0x21	
PVIN for Buck1	ADC_SAMPLE2MSB/LSB	0x22	0x23	
V <sub>OUT1</sub>	ADC_SAMPLE3MSB/LSB	0x24	0x25	
Buck2 Ph1 Current	ADC_SAMPLE4PH1MSB/LSB	0x26	0x27	
Buck2 Ph2 Current	ADC_SAMPLE4PH2MSB/LSB	0x28	0x29	
Buck2 Total Current	ADC_SAMPLE4TMSB/LSB	0x2A	0x2B	
PVIN for Buck2	ADC_SAMPLE5MSB/LSB	0x2C	0x2D	
V <sub>OUT2</sub>	ADC_SAMPLE6MSB/LSB	0x2E	0x2F	
AUX INPUT0	ADC_AUX0MSB/LSB	0x30	0x31	
AUX INPUT1	ADC_AUX1MSB/LSB	0x32	0x33	

#### Table 8. ADC Register Addresses

The ADC 16-bit output data LSB is 0.25 when referring to temperature, voltage, or individual phase current. The total buck current measurement has an LSB of 1. See <u>Table 9</u>.



Each channel is filtered through an internally programmable infinite impulse response (IIR) filter. AUX input 0 and AUX input 1 allow you to read the external values with the ISL91302B ADC. Setting the IIR coefficient of a channel to 1 provides no filtering, whereas the 1/128 setting provides the most filtering. The IIR filter coefficient should be set to 1 (code 0x0) in one-shot mode of operation.

Contact support for questions relating to the ADC.

		able 9. ABC Result in	111 5	
16-bit ADC Data (hex)	Phase Current (mA)	Total Buck Output Current (mA)	Die Temperature (°C)	Buck Output Voltage (mV)
0x0000	0	0	0	0
0x0001	0.25	1	0.25	0.25
0x0002	0.5	2	0.5	0.5
0x0003	0.75	3	0.75	0.75
0x0004	1	4	1	1
0x0010	4	16	4	4
0x0100	64	256	64	64
0x7FFF	8191.75	32767	8191.75	8191.75
0x8000	-8192	-32768	-8192	-8192
0x8001	-8191.75	-32767	-8191.75	-8191.75
0xFFFF	-0.25	-1	-0.25	-0.25

Table 9. ADC Result Mapping

# 5.5 Dynamic Voltage Scaling (DVS)

The ISL91302B has several options to achieve DVS. Each buck controller has four independently programmable voltage settings to set the output voltage. The settings are DVS0, DVS1, DVS2, and DVS3. Changing the selected DVS number selects the corresponding output voltage. The two methods to select the DVS are:

**Method 1)** - Use internal registers to select DVS by writing to the BUCKx\_DVSSELECT[1:0] bits in the BUCKx\_DVSSEL register for each respective buck using SPI or  $I^2C$ .

To use this method, the BUCKx\_DVSCTRL[0] bit has to be set to 0x0 for the corresponding buck. The BUCKxDVSSELECT[1:0] setting allows the user to switch between the four different DVS settings, each of which corresponds to a set of DVS registers holding the DVS information.

For example, DVS0 correponds to BUCKx\_DVS0VOUT92[7:0] and BUCKx\_DVS0VOUT10[1:0]. The two register values combined represent the complete 10-bit DAC code for DVS0.

BUCKx_DVSCTRL[0]		
0x0	Use BUCKx_DVSSELECT[1:0] to select active DVS configuration	
0x1	Use DVS pin(s) to control DVS selection	

#### Table 11. DVS Pointers

BUCKx_DVSSELECT[1:0]	Active DVS for BUCKx	
0x0	DVS0	



(EQ. 1)

BUCKx_DVSSELECT[1:0]	Active DVS for BUCKx				
0x1	DVS1				
0x2	DVS2				
0x3	DVS3				

#### Table 11. DVS Pointers

Each output voltage is set writing a 10-bit word to DVS Configuration 1 (BUCKx\_DVS0CFG1 register) and DVS Configuration 0 (BUCKx\_DVS0CFG0 register) in each buck. Configuration 1 holds the eight most significant bits and Configuration 0 holds the last two bits of the 10-bit word. The output voltage does not change until the LSB register has been written.

Equation 1 relates the DVS word and  $V_{OUT}$  target.

 $V_{OUT} = \frac{1.234V}{FBDIV} \times \frac{DAC\_CODE}{1024}$ DAC\_CODE: 0 ~ 1023d; FBDIV(selection): 1, 0.8, or 0.6

In the application, the 10-bit DVS word should be set to ensure the buck output voltage target is always 0.3V or above.

**Method 2)** - Using GPIO/MPIO pins to achieve DVS, there are five variations depending on the IO\_PINMODE register setting. See <u>Table 2</u>.

NOTE: To use DVS by GPIO/MPIO pins requires IO\_PINMODE to be OTP programmed before a start-up boot sequence is initiated. On-the-fly programming is not recommended for the following configurations.

(i) IO\_PINMODE = 0x3: SPI with two Independent Buck DVS pins

MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1
SCK	SS_B	MOSI	MISO	DVS1_0	DVS2_0

BUCKx\_DVSCTRL[0] should be OTP programmed high before the start-up sequence. The active DVS follows the DVSx\_0 pin logic for the respective buck. See <u>Table 12</u> for more information.

#### Table 12. Single DVS Pin Logic

Function				
DVS1_0	Active DVS for BUCK1			
0	DVS0			
1	DVS1			
DVS2_0	Active DVS for BUCK2			
0	DVS0			
1	DVS1			

(ii) IO\_PINMODE = 0x4: I<sup>2</sup>C with Global DVS and PGOOD pins

MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1
DVS_PIN1	DVS_PIN0	PGOOD1	PGOOD2	SCL	SDA

BUCKx\_DVSPIN\_CTRL[1:0] bits in BUCKx\_DVSCFG register in combination with the DVS\_PIN1 and DVS\_PIN2 sets the active DVS for the respective BUCK. See <u>Table 13</u> for more information. BUCKx\_DVSCTRL[0] should be OTP programmed high before the start-up sequence.



		-	
BUCKx_DVSPIN_CTRL[1:0]	DVS_PIN1	DVS_PIN0	Active DVS
0x0	Х	Х	DVS0
0x1	Х	0	DVS0
	Х	1	DVS1
0x2	0	Х	DVS0
	1	Х	DVS2
0x3	0	0	DVS0
	0	1	DVS1
	1	0	DVS2
	1	1	DVS3

Table 13	. Global DVS P	in Logic
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Note: The 'X' indicates that either a 0 or 1 is acceptable.

#### (iii) **IO\_PINMODE = 0x5:** I<sup>2</sup>C with 2 DVS pins for Buck1 and 2 DVS pins for Buck2

MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1
DVS1_0	DVS1_1	DVS2_0	DVS2_1	SCL	SDA

The active DVS is selected based off the combined DVSx\_1 and DVSx\_2 input pin logic. See <u>Table 14</u> for more information. BUCKx\_DVSCTRL[0] should be OTP programmed high before the start-up sequence.

#### Table 14. Active DVS for 2 DVS Pins Configuration

DVSx_1	DVSx_0	Active DVS for BUCKx
0	0	DVS0
0	1	DVS1
1	0	DVS2
1	1	DVS3

(iv) IO\_PINMODE = 0x6: I<sup>2</sup>C with 2 DVS pins and 2 PGOOD pins

MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1
DVS1_0	DVS2_0	PGOOD1	PGOOD2	SCL	SDA

BUCKx\_DVSCTRL[0] should be OTP programmed high before the start-up sequence. DVS1\_0 and DVS2\_0 follows the same active DVS table as in IO\_PINMODE = 0x3. See <u>Table 12</u> for more information.

(v) **IO\_PINMODE = 0xE:** I2C with 2 DVS pins and 2 AUX ADC pins

MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1
ADC_IN0	ADC_IN1	DVS_PIN1	DVS_PIN2	SCL	SDA

DVS\_PIN0 and DVS\_PIN1 behave the same as in IO\_PINMODE = 0x4. See <u>Table 13</u> for more information. BUCKx\_DVSCTRL[0] should be OTP programmed high before the start-up sequence.



# 5.6 Configuring DVS Speed

# 5.6.1 Power-Up and Shutdown Slew Rate Setting

The BUCKx\_RSPPUP[2:0] bits in the BUCKx\_RSPCFG0 register set the slew rates (DVS speed) in BUCKx only during  $V_{OUTx}$  power-up. Similarly, the BUCKx\_RSPPDN[2:0] in the BUCKx\_RSPCFG0 register sets the slew rates in BUCKx during normal  $V_{OUTx}$  shutdown. The achievable slew rates varies with different FBDIV settings (factory OTP programmed). For more details, see Register <u>BUCK1\_RSPCFG0</u>.

# 5.6.2 DVS Transition Slew Rate Setting

BUCKx\_RSPUP[2:0] and BUCKx\_RSPDN[2:0] in the BUCKx\_RSPCFG1 register sets the slew rates (DVS speed) in BUCKx during normal DVS transition. The achievable slew rates varies with different FBDIV settings (factory OTP programmed). For more details, see Register <u>BUCK1\_RSPCFG1</u>.

# 5.7 Output Voltage Setting

Each output voltage is set by writing a 10-bit word to DVS Configuration 1 (BUCKx\_DVS0CFG1 register) and DVS Configuration 0 (BUCKx\_DVS0CFG0 register) in each buck. Configuration 1 holds the MSB and Configuration 0 holds the last two bits of the 10-bit word. The output voltage does not change until the LSB register has been written. <u>BUCK1\_DVS0CFG1</u> shows the relationship between the DVS word and V<sub>OUT</sub>.

# 5.8 Power Sequencing

When the master chip Enable (EN) pin is brought above an NMOS threshold, the ISL91302B powers up its key biasing circuits, loads the OTP configuration registers, and does one of two things based on the preprogrammed OTP setting:

#### (1) Manual buck start-up:

Program the internal IO\_BUCKx\_EN bits to 1 from I<sup>2</sup>C/SPI to enable the respective buck. When IO\_PINMODE = 0x1, the EN\_A and EN\_B pins can also be used to enable the respective bucks. If using IO\_PINMODE = 0x1, the internal IO\_BUCKx\_EN bits should be set high in OTP. The slew rate of each buck during its soft-start is specified by the BUCKx\_RSPPUP[2:0] bits.

Note: The programmable (1ms to 63ms) delay using BUCKx\_EN\_DLY[5:0] is not used for Manual Buck start-up.

#### (2) Auto Buck start-up from master chip enable pin:

Run a predetermined start-up sequence for the buck outputs as soon as BOOT is complete. The slew rate of each buck during its soft-start is specified in BUCKx\_RSPPUP[2:0].

**Note:** The delay, BUCKx\_EN\_DLY[5:0] shown in Figure 21 as EN\_dlyx, is programmable from 0 to 63ms in 1ms steps.

<u>Figure 21</u> provides an example of power-up configurability. The master chip enable pin (EN) transitions from 0 to 1 and OTP is loaded over 1.4ms. After the initial 1.4ms boot interval, the buck output start-up sequence begins. In the <u>Figure 21</u> example, BUCK1\_EN\_DLY is set for 0ms and BUCK2\_EN\_DLY is set for 1ms.



Figure 21. Master Chip Enable Power-Up Example



The buck outputs can also be programmed to execute a controlled shutdown in two ways:

(1) Manual buck power-down:

Program the internal IO\_BUCKx\_EN bit to 0 through I<sup>2</sup>C/SPI or lower the Buck Enable pin (EN\_A or EN\_B when IO\_PINMODE = 0x1). The manual method can be used to power down a specific buck (with a controlled slew rate) while keeping the rest of the chip alive.

**Note:** The programmable (0ms to 63ms) delay from BUCKx\_SHUTDN\_DLY[5:0] is not used for manual buck power-down.

#### (2) Auto Buck power-down from master chip enable pin:

When the master chip Enable pin (EN) is brought below the falling threshold of the comparator, the Bucks are ramped down at a controlled rate using preprogrammed delays. This is then followed by the power-down of the bias circuits forcing the chip into shutdown. The slew rate of each buck during its power-down (down to  $\sim$ 250mV) is specified in BUCKx\_RSPPDN[2:0].

**Note:** The delay, BUCKx\_SHUTDN\_DLY[5:0] shown in <u>Figure 22</u> as Dis\_dlyx, is programmable from 0 to 63ms in 1ms steps.

<u>Figure 22</u> provides an example of power-down configurability. The master chip enable pin (EN) transitions from logic 1 to 0. In the <u>Figure 22</u> example, BUCK1\_SHUTDN\_DLY is set for 1ms and BUCK2\_SHUTDN\_DLY is set for 2ms.



Figure 22. Auto Chip Power-Down Example

The actual slew rate that each buck ramps down to is specified by the register BUCKx\_RSPSHUTDN. This slew rate is controlled until the output voltage is ~250mV, at which point the ISL91302B engages a weak resistive pull-down (if enabled by factory OTP) that can keep  $V_{OUT} = 0V$  when the buck is not enabled. Figure 23 shows an example of the weak pull-down behavior.

• **Option 1:** If the disable event for a buck output is the master chip enable pin (EN) falling below its logic low threshold, then when the output falls below 250mV, the output voltage decay is dictated by the system load passively discharging the buck output capacitance. PULL\_DOWN\_DISCHARGE IO\_MPIO\_DATA[4] bit per the IO MPIO DATA register is **not** used in this method.

• **Option 2:** If the disable event for a buck output is the master chip enable pin (EN) remaining high and the enable register bit (IO\_BUCKx\_EN) transitioning from a logic 1 to a logic 0, then PULL\_DOWN\_DISCHARGE IO\_MPIO\_DATA[4] bit per the IO\_MPIO\_DATA register is used enabling an internal weak pull down.

Note: The weak pull-down can be disabled (using factory OTP).



Figure 23. Buck Disable Waveform



# 5.9 Watchdog Time (WDOG\_RST Pin)

The ISL91302B implements a watchdog function that allows the output voltages to return to a safe default when communication to the processor host is lost. If the WDOG\_RST pin goes into the failure state for a duration greater than the programmed debounce time, the default voltages from OTP are restored.

The IO\_RSTDVS\_CTRL[1:0] bits select which buck(s) respond to the WDOG\_RST pin. The polarity of the WDOG\_RST pin is active low.

#### Table 15. WDOG\_RST Function

Action							
At Boot Up	DVS registers are loaded with values stored in OTP.						
After Debounce Time	Restore selected output voltages to their original values stored in OTP (DVS0), and slew the buck outputs to that voltage.						

The total recovery time for the buck is the sum of  $t_{SLEW}$  and  $t_{DEBOUNCE}$ . The target voltage WDOG\_RST pin resets the ISL91302B buck output(s), set by DVS0, that are in the BUCKx\_DVS0CFG1 and BUCKx\_DVS0CFG0 registers.

t<sub>SLEW</sub> is determined by BUCKx\_RSPUP[2:0] and BUCKx\_RSPDN[2:0]. t<sub>DEBOUNCE</sub> is factory programmable.



Figure 24. Watchdog Timer Example Case

### 5.10 Interrupt Pin

The ISL91302B can alert the host when a warning or a fault has occurred through an IRQ interrupt request signal with configurable masking options that is connected to a configurable interrupt (INT) pin. The interrupt pin can be programmed to be active high, active low, an open drain, or a CMOS output.





Figure 25. Interrupt Tree

### 5.11 Decay Mode

When the output voltage is programmed to a lower value than the present voltage, you can use Decay mode to reduce the output voltage only at the rate that the output load it is pulling down. This can improve efficiency when lowering the voltage at a controlled rate is not necessary. BUCKx\_DVS0DECAY can be programmed to enable or disable Decay mode.



# 6. Protection Features (Faults)

The ISL91302B has integrated Overcurrent (OC), Overvoltage (OV), Undervoltage (UV), and Over-Temperature (OT) protection features.

# 6.1 Over-Temperature Protection

The ISL91302B provides protection against over-temperature conditions. An over-temperature protection circuit continuously monitors the die temperature of the chip and raises a fault when the temperature exceeds a predefined limit programmed by Register <u>"FLT\_TEMPSHUTDN"</u>. The ISL91302B also contains a programmable thermal warning threshold set by Register <u>"FLT\_TEMPWARN"</u>. Programmable Hysteresis enables the circuit to clear the fault or warning once the temperature is below a user-defined safe temperature. The warning and shutdown hysteresis level are factory programmable. Contact Renesas <u>support</u> for custom settings. The over-temperature protection is disabled if all bucks are operating in PFM mode or in the off state.

### 6.2 Overcurrent Protection Mode

The ISL91302B has a comparator-based OCP and an ADC-based OCP mechanism. The comparator based OCP or 'WOC' block has a current comparator that compares the load current through the high-side power FET with the reference current level through a replica device. If the sensed FET current is higher than the WOC threshold, the WOC is triggered immediately, preventing a catastrophic condition. The WOC disables the buck and latches the power-stage into tri-state until the fault is cleared. The WOC fault is self-cleared when the OC condition is removed. The buck attempts to re-enable in a "hiccup" type fashion. The ADC-based OCP monitors the averaged high-side and low-side MOSFET current for each phase and is slower but more accurate than the comparator-based WOC. If the Buck total current is higher than the ADC based OCP threshold, the ADC OCP is triggered, which shuts down the Buck and latches the power-stage into tri-state. ADC-based OCP can be cleared only by recycling the PVIN/AVIN or by toggling the EN pin. Note that the ADC-based OC cannot be cleared by toggling the IO\_BUCKx\_EN bit by I<sup>2</sup>C/SPI.

Overcurrent protection can be enabled or disabled using the fault register setting in FLT\_BUCKx\_CTRL. ADC-based current warning limits can be adjusted with the FLT\_BUCKx\_ISENSEWARN register. ADC-based current shutdown limits can be adjusted with the FLT\_BUCKx\_ISENSESHUTDN register.

# 6.3 Overvoltage (OV)/Undervoltage (UV) Protection

The OV/UV protection circuitry has low power comparators configured with differential input and single-ended outputs capable of working over large common-mode input ranges. This comparator monitors the output voltage in both DCM and CCM for faults. By default, when an OV/UV event is triggered, the buck converter is shut down until the fault is cleared. Fault control register FLT\_BUCKx\_CTRL enables or disables the functionality. The OV/UV limits are adjustable using the BUCKx\_UVOVTH[1:0] bits in the BUCKx\_PROTCFG register. See <u>Table 16</u> for more details.

BUCKxUVOVTH[1:0]	OV/UV Threshold
0x0	±150mV around DAC target
0x1	±200mV around DAC target
0x2	±250mV around DAC target
0x3	±300mV around DAC target

Table 10. Ov/Ov Frotection Thesholds	Table 1	16. OV/L	JV Protect	ion Thresholds
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# 7. Serial Communication Interface

The ISL91302B has two serial interface protocols to read/write the registers.

- SPI
- I<sup>2</sup>C



Figure 26. SPI and I<sup>2</sup>C Interface Block Diagram

The arbitration of the register access bus between SPI and I<sup>2</sup>C is determined by the pad MPIO1 when using IO\_PINMODE = 0x0, as shown in Table 17:

Table 17. SPI/I<sup>2</sup>C Register Access

Register IO_PINMODE	Pad MPIO_1 (SS_B)	Register Access
0	0	SPI (read/write access ( <u>Note 11</u> ))
	1	I <sup>2</sup> C ( <u>Note 12</u> )

Notes:

11. When the device is configured for SPI access, the I<sup>2</sup>C should not be addressed with the device ID.

12. When the device is configured for I<sup>2</sup>C access in PINMODE 0, the SS\_B line must be held high.

After switching from SPI to I<sup>2</sup>C or vice versa, a minimum of 50ns wait time is required before starting a transaction.

### 7.1 SPI Serial Interface

The SPI interface is a general specification 4-wire slave interface capable of operating at a clock speed of up to 26MHz. It is based on byte transfers. The ISL91302B does not support SPI reads on the MISO bus when using multiple slave devices on the same bus.

# 7.1.1 SPI Data Protocol

Both Read and Write SPI transactions begin when SS\_B goes low and end when SS\_B goes high.

### 7.1.1.1 Write Operation

To write to the ISL91302B, the master (controller) needs to drive SS\_B low, then send the Control Byte followed by the register address, packet length (if IO\_SPIMODE = 1), and data bytes to be written. The controller drives SS\_B high to terminate the transaction as shown in Figure 27.





#### Figure 27. SPI Write Transaction with IO\_SPIMODE = 1; IO\_SPICPOL = 0; IO\_SPICPHA = 0

The MSB of the Control byte is the R/W bit, which needs to be set to 'write' operation (see <u>"IO\_SPIRWPOL"</u> on page 52). Bit 6, AI indicates whether the operation is a single-byte write a multi-byte write. Bits 1 and 0 of the Control byte indicate the page number of the register location to be written (MSBs of the register address). The register address byte is the 8-bit address of the register within the page specified by the Page[1:0] bits. If  $IO_SPIMODE = 1$ , the register address needs to be followed by an 8-bit packet length that indicates the number of bytes to be written. After the packet length field, the master needs to send the data bytes. When all eight bits of data are received, they are written to the specified register address and the ISL91302B increments the register address.

In single byte transactions, (AI = 0 or Packet length = 1), the ISL91302B goes into the wait state and waits for SS\_B to go high.

In multi-byte transactions with IO\_SPIMODE = 1, the ISL91302B writes the subsequently received data bytes to sequentially incrementing addresses until the number of bytes, as specified by 'packet length', are received, then goes into the wait state and waits for SS\_B to go high. For multi-byte transactions with IO\_SPIMODE = 0 and AI = 1, the ISL91302B keeps writing the subsequently received data bytes to sequentially incrementing addresses until SS\_B goes high. If SS\_B goes high in the middle of a transaction, the transaction is terminated. The data byte is written if all eight bits are received.

### 7.1.1.2 Read Operation

To read from the ISL91302B, the master (controller) needs to drive SS\_B low then send the Control Byte followed by the register address and packet length (if IO\_SPIMODE = 1). The ISL91302B then sends the data bytes from the requested registers. Finally, the master drives SS\_B high to terminate the transaction. The MSB of the Control byte is the R/W bit, which needs to be set to 'read' operation (see <u>"IO\_SPIRWPOL" on page 52</u>). Bit 6, whether the operation is a single-byte read or a multi-byte read. Bits 1 and 0 of the Control byte indicate the page number of the register location be read (MSBs of the register address). The register address byte is the 8-bit address of the register within the page specified by the Page[1:0] bits. If IO\_SPIMODE = 1, the register address needs to be followed by an 8-bit packet length that indicates the number of bytes to be written. Following the packet length field, the ISL91302B will send the data from the requested register. When all eight bits of data from the requested register address are sent, the ISL91302B increments the register address.

In a single-byte transaction, (AI = 0 or Packet length = 1), the ISL91302B goes into a wait state and waits for SS\_B to go high.

In a multi-byte transaction with IO\_SPIMODE = 1, the ISL91302B sends the data bytes from sequentially incrementing addresses until the number of bytes as specified by 'packet length' are sent and then goes into a wait state and waits for SS\_B to go high. For multi-byte transactions with IO\_SPIMODE = 0 and AI = 1, the ISL91302B keeps sending data bytes from sequentially incrementing addresses until SS\_B goes high.

Note: The MISO pin is pulled low while SS\_B is high.





\* Only present when IO\_SPIMODE = 1 ^ Only present for Multi Word Transactions

#### Figure 28. SPI Read Transaction with IO\_SPIMODE = 1; IO\_SPICPOL = 0; IO\_SPICPHA = 0

R/W	Read/Write Bit Indicating Read or Write Operation
AI	Auto Increment. 1 indicates a multi-byte transfer, 0 indicates a single byte transfer
Page	2-bit page address of the register to be written or read
Address	8-bit register address of the register to be written or read
Packet Length	8-bit packet length indicating number of data bytes to be transferred. Overrides AI when IO_SPIMODE = 1
Read Data	Data in the register at Address [7:0] + n
Write Data	Data to be written to the register at Address [7:0] + n

### 7.1.2 SPI Configuration

The following register bits configure the SPI operation:

- **IO\_SPICPOL:** SPI clock polarity, ISL91302B is configured as active high, IO\_SPICPOL = 0
- IO\_SPICPHA: SPI clock phase, ISL91302B samples data on rising edge of SPI clock, IO\_SPICPHA = 0

The four possible clocking modes are shown in Figure 29.





• **IO SPIRWPOL**: R/W bit polarity, ISL91302B SPI RWPOL is set to 0. 1 = Read, 0 = Write

SPI_RWPOL	R/W	Operation
0	0	Write
0	1	Read

• **IO\_SPIMODE**: Packet length enable. The ISL91302B uses packet length mode by default, meaning the third data byte from master is the packet length and indicates the total number of data words to be sent or received in a burst transaction

# 7.1.3 SPI Timing

<u>Figure 30 on page 34</u> shows SPI timing for IO\_SPICPOL = 0; IO\_SPICPHA = 0. The timing values in <u>Table 18</u> on page 34 hold true for other values of IO\_SPICPOL, IO\_SPICHPA as well.

Parameter	Symbol	Min	Мах	Units								
Clock Period	t <sub>1</sub>	38.4		ns								
Enable Lead Time	t <sub>2</sub>	12		ns								
Enable Lag Time	t <sub>3</sub>	12		ns								
Clock High or Low Time	t <sub>4</sub>	15		ns								
Data Setup Time (Input)	t <sub>5</sub>	12		ns								
Data Hold Time (Input)	t <sub>6</sub>	10		ns								
Time MISO is Stable before the Next Rising Edge of CLK	t <sub>7</sub>	5		ns								
Data Held after Clock Edge (Output)	t <sub>8</sub>	5		ns								
Load Capacitance	CL		10	pF								

Tablo	18	Timina	Values
lable	10.	runnig	values



Figure 30. SPI Timing for IO\_SPICPHA = 0, IO\_SPICPOL = 0

# 7.2 I<sup>2</sup>C Interface

The I<sup>2</sup>C interface is a simple bidirectional 2-wire bus protocol that consists of the Serial Clock Control (SCL) and the Serial Data Signal (SDA). The ISL91302B hosts a slave I<sup>2</sup>C interface that supports data speeds up to 3.4Mbps. SCL is an input to the ISL91302B and is supplied by the controller. SDA is bidirectional. The ISL91302B has an open-drain output to transmit data on SDA. An external pull-up resistor must be placed on the serial data line to pull the drain output high during data transmission.

The ISL91302B uses a 7-bit hardware address scheme. The default address is set to 0x1D by a one-time programmable fuse.



# 7.2.1 I<sup>2</sup>C Bus Operation

The chip supports 7-bit addressing. The ISL91302B I<sup>2</sup>C device address is reconfigurable through the OTP.

All communication over the I<sup>2</sup>C interface is conducted by sending the MSB of each byte of data first. Data states on the SDA line can change only during SCL LOW periods. SDA state changes during SCL HIGH are reserved for indicating START and STOP conditions (see Figure 35 on page 36).

All I<sup>2</sup>C interface operations must begin with a START condition, which is a HIGH to LOW transition of SDA while SCL is HIGH. The ISL91302B continuously monitors the SDA and SCL lines for the START condition and does not respond to any command until this condition is met. All I<sup>2</sup>C interface operations must be terminated by a STOP condition, which is a LOW to HIGH transition of SDA while SCL is HIGH.

An Acknowledge (or ACK), is a software convention that indicates a successful data transfer. The transmitting device, either master or slave, releases the SDA bus after transmitting eight bits. During the ninth clock cycle, the receiver pulls the SDA line LOW to acknowledge the reception of the eight bits of data (Figure 35 on page 36). The ISL91302B responds with an ACK after recognizing a START condition, followed by a valid Identification Byte (also known as I<sup>2</sup>C Address). The ISL91302B also responds with an ACK after receiving a Data Byte of a write operation. The master must respond with an ACK after receiving a Data Byte of a read operation.

# 7.2.1.1 Write Operation

A Write operation requires a START condition, followed by an ISL91302B I<sup>2</sup>C Address byte with the R/W bit set to 0, a Register Address Byte, Data Bytes, and a STOP condition. After each byte, the ISL91302B responds with an ACK. After every data byte, the ISL91302B auto increments the register address so subsequent data bytes get written to sequentially incremental register locations. A STOP condition that terminates the write operation must be sent by the master after sending at least one full data byte and its associated ACK signal. If a STOP byte is issued in the middle of a data byte, the write is not performed.



Figure 31. 1-Byte Write to Register M



Figure 32. L-Byte Sequential Data Write Starting Register M

# 7.2.1.2 Read Operation

A Read operation consists of a three-byte "dummy write" instruction to send the register address to begin reading from, followed by a Current Address Read operation. The master initiates the operation, issuing the following sequence: a START condition, followed by an ISL91302B I<sup>2</sup>C Address byte with the R/W bit set to "0", a Register Address Byte, a second START, and a second ISL91302B I<sup>2</sup>C Address byte with the R/W bit set to "1". After each of the three bytes, the ISL91302B responds with an ACK. The ISL91302B then transmits Data Bytes. The master terminates the Read operation from the ISL91302B by issuing a STOP condition following the last bit of the last data byte. After every data byte, the ISL91302B auto increments the register address so subsequent data bytes are sent from sequentially incremental register locations.



▶ 1 2 7 8 9 1 2 7 8 9 <b>5</b> 1 2												7	8	9	1	2		7	8	9						
STAR			ICE I2C		0	ACK		Re	g Addı M	ess		ACK	RESTAI	DEVICE I2C ADDRESS			DEVICE I2C				d Data Reg N		n	ACK	STOP	
1 Byte Data Read from Register M																										

Figure 33. 1-Byte Data Read from Register M



Figure 34. L-Byte Sequential Data Read Starting Register M

# 7.2.2 I<sup>2</sup>C Timing

The timing specifications of the I<sup>2</sup>C I/O from the I<sup>2</sup>C specification are shown in <u>Figure 35</u> and <u>Table 19 on</u> page 37. The I<sup>2</sup>C controller provides a slave I<sup>2</sup>C transceiver capable of interpreting I<sup>2</sup>C protocol in Standard, Fast, Fast+, and High Speed modes.



Figure 35. I<sup>2</sup>C Timing


*<i>ENESAS* 

		Та	ble 19. l <sup>2</sup>	C Specification						
			ard Mode	Fast Mode		Fast Mode Plu	IS	High Speed	l Mode	
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Clock Frequency	f <sub>SCL</sub>	0	100	0	400	0	1000	0	3400	kHz
Hold Time (repeated) START Condition (after this period, the first clock pulse is generated)	t <sub>HD</sub> ;STA	4000	-	600	-	260	-	160	-	ns
LOW Period of the SCL Clock	t <sub>LOW</sub>	4700	-	1300	-	500	-	160	-	ns
HIGH Period of the SCL Clock	t <sub>HIGH</sub>	4000	-	600	-	260	-	60	-	ns
Setup Time for a Repeated START Condition	t <sub>SU;STA</sub>	4700	-	600	-	260	-	160	-	ns
Data Hold Time	t <sub>HD;DAT</sub>	15	-	15	-	15	-	15	70	ns
Data Setup Time	t <sub>SU;DAT</sub>	250	-	100	-	50	-	10	-	ns
Rise Time of SCL	t <sub>rCL</sub>	-	1000	-	300	-	120	-	40	ns
Fall Time of SCL	t <sub>fCL</sub>	-	300	-	300	20 × (V <sub>DD</sub> /5.5V)-	120	-	40	ns
Rise Time of SDA	t <sub>rDA</sub>	-	1000	20	300	-	120	10 <u>(Note 14)</u>	80	ns
Fall Time of SDA	t <sub>fDA</sub>	-	300	20 × (V <sub>DD</sub> /5.5V) ( <u>Note 13)</u>	300	20 × (V <sub>DD</sub> /5.5V) ( <u>Note 13)</u>	120	10 <u>(Note 14)</u>	80	ns
Setup Time for STOP Condition	t <sub>SU;STO</sub>	4000	-	600	-	260	-	160	-	ns
Bus Free Time between a STOP and START Condition	t <sub>BUF</sub>	4700	-	1300	-	500	-	-	-	ns
Capacitive Load for each Bus Line	Cb	-	400	-	400	-	400		100	pF
Output Fall Time from VIHmin to VILmax	t <sub>of</sub>	-	250[5]	20 × (V <sub>DD</sub> /5.5V)[6]	250[5]	20 × (V <sub>DD</sub> /5.5V)[6]	120[7]	10 <u>(Note 14)</u>	80	ns
Pulse Width of Spikes Suppressed by the Input Filter	t <sub>SP</sub>	-	-	0	50	0	50	0	10	ns

Notes:

13. Only valid for  $V_{DD}$  < 4V. 14. Only valid for  $V_{DD}$  < 1.9V. 15.  $V_{DD}$  is the pull-up source to the I<sup>2</sup>C lines (GPIO0, GPIO1).

## 8. Board Layout Recommendations

Proper PCB layout is a very important design practice to ensure a satisfactory performance from the ISL91302B high frequency multiphase switching regulator. The power loop consists of the output inductor L, the output capacitor  $C_{OUT}$ , the PH pin, and the PGND pin. It is important to make the power loop as small as possible. The connecting traces among them should be direct, short, and wide. The same practice should be applied to the connections of the PVIN pin, the input capacitor, and PGND. The switching node of the converter, the PH pin, and the traces connected to this node are very noisy, so keep the VOUT and RTN lines and other noise sensitive traces away from these traces. Place the input capacitors as close as possible to the PVIN(s) and PGND(s) pins. Connect the ground of the input and output capacitors as close as possible. A solid ground plane is helpful for a good EMI performance.

Inductor placement should be as close to the phase pins as possible. Use wide traces and reduce the length to improve the overall efficiency and reduce the amount of radiated EMI. For the phase traces, Renesas recommends descending one layer to reduce the effective path to the inductor. Match the length and width of each inductor trace and number of microvias to help ensure proper current sharing between phases.

Place an AVIN filter capacitor as close as possible to the AVIN\_FILT pin but away from noise sources. Always reference the GND pad of the decoupling capacitor to a quiet GND plane.

Do not use plated through-holes when passing the WLCSP pins to lower layers. If microvias are required to pass down multiple layers, Renesas recommends staggering them.

The VOUT and RTN lines are used to sense the output voltage and should be routed directly to the load. Connecting the RTN line to ground away from the load causes a ground error in the output voltage load regulation due to parasitic ground resistance. Keep these traces away from switching nodes such as converter phase nodes or high-speed digital signals. Use small low inductance capacitors at the load to improve noise immunity and transient response to the ISL91302B.



Figure 36. Recommended PCB Layout Top Layer





Provide a solid ground plane in the adjacent layer to provide a low impedance path to support high current flow. Copper planes need to be parallel with the phase traces on the top layer to minimize resistance, and they must be surrounded by a GND plane to prevent noise coupling.

Figure 37. Recommended PCB Layout Second Layer



Figure 38. Recommended PCB Layout Bottom Layer



### 8.1 PCB Layout Summary

- Place input capacitors as close as possible to their respective PVIN and PGND pins
- Route phase nodes with short, wide traces and avoid any sensitive nodes
- Route VOUT and RTN lines differentially to the load and use small low ESL capacitors at the load for bypassing
- Output capacitors should be close to the inductors and have a low impedance path to the PGND pins
- Keep digital and phase nodes from intersecting AVIN\_FILT, VOUT, and RTN lines on adjacent layers

## 8.2 PCB Design for WLCSP Recommendations

Design Feature	Design Specification
Cu Pad Diameter	0.4mm pitch: 0.215 ±0.012mm
Microvia Structure	All microvias should be copper filled.
Microvia Stacking	Avoid microvia stacking if possible. Use staggered vias instead. If microvia stacking is absolutely necessary for the layout, the maximum number of recommended via stacks is two.
Plated Through-Hole (PTH) Location	No PTH should be placed under the CSP bump pads. Microvias and trace routing should be used to fan the PTH away from the CSP bump array.



## 9. Register Address Map

When communicating with registers that contain reserved bits, Renesas recommends performing a masked write/read to avoid modifying sensitive register values.

Address	Register	Address	Register	Address	Register
0x01	IO_CHIPNAME	0x30	ADC_AUX0MSB	0x74	BUCK1_DVS1CFG1
0x0F	IO_SOFTRESET	0x31	ADC_AUX0LSB	0x75	BUCK1_DVS1CFG0
0x10	CHIPSTATE	0x32	ADC_AUX1MSB	0x76	BUCK1_DVS2CFG1
0x11	CHIPSTATE_DCMPGOOD	0x33	ADC_AUX1LSB	0x77	BUCK1_DVS2CFG0
0x13	FLT_RECORDTEMP	0x43	IO_SPICFG	0x78	BUCK1_DVS3CFG1
0x14	FLT_RECORDBUCK1	0x44	IO_MODECTRL	0x79	BUCK1_DVS3CFG0
0x15	FLT_RECORDBUCK2	0x45	IO_RSTDVS	0x7A	BUCK1_VOUTMAXMSB
0x16	ADC_SAMPLE0MSB	0x46	IO_PINMODE	0x7B	BUCK1_VOUTMAXLSB
0x17	ADC_SAMPLE0LSB	0x50	ADC_RATECCMDCM	0x7C	BUCK1_DVSCFG
0x18	ADC_SAMPLE1PH1MSB	0x51	ADC_RATEIDLE	0x7D	BUCK1_DVSSEL
0x19	ADC_SAMPLE1PH1LSB	0x52	ADC_TEMPCFG	0x7E	BUCK1_RSPCFG1
0x1A	ADC_SAMPLE1PH2MSB	0x53	ADC_BUCK1CFG	0x7F	BUCK1_RSPCFG0
0x1B	ADC_SAMPLE1PH2LSB	0x54	ADC_BUCK2CFG	0x80	BUCK1_EN_DLY
0x1C	ADC_SAMPLE1PH3MSB	0x55	ADC_AUXRATECFG	0x81	BUCK1_SHUTDN_DLY
0x1D	ADC_SAMPLE1PH3LSB	0x58	FLT_TEMPWARN	0x82	BUCK2_EA2
0x1E	ADC_SAMPLE1PH4MSB	0x59	FLT_TEMPSHUTDN	0x85	BUCK2_DCM
0x1F	ADC_SAMPLE1PH4LSB	0x5A	FLT_TEMPHYS	0x86	BUCK2_CFG3
0x20	ADC_SAMPLE1TMSB	0x5B	FLT_BUCK1_ISENSEWARN	0x8A	BUCK2_PROTCFG
0x21	ADC_SAMPLE1TLSB	0x5C	FLT_BUCK2_ISENSEWARN	0x8E	BUCK2_DVS0CFG1
0x22	ADC_SAMPLE2MSB	0x5D	FLT_BUCK1_ISENSESHUTDN	0x8F	BUCK2_DVS0CFG0
0x23	ADC_SAMPLE2LSB	0x5E	FLT_BUCK2_ISENSESHUTDN	0x90	BUCK2_DVS1CFG1
0x24	ADC_SAMPLE3MSB	0x60	FLT_MASKTEMP	0x91	BUCK2_DVS1CFG0
0x25	ADC_SAMPLE3LSB	0x61	FLT_MASKBUCK1	0x92	BUCK2_DVS2CFG1
0x26	ADC_SAMPLE4PH1MSB	0x62	FLT_MASKBUCK2	0x93	BUCK2_DVS2CFG0
0x27	ADC_SAMPLE4PH1LSB	0x63	FLT_OT_CTRL	0x94	BUCK2_DVS3CFG1
0x28	ADC_SAMPLE4PH2MSB	0x64	FLT_BUCK1_CTRL	0x95	BUCK2_DVS3CFG0
0x29	ADC_SAMPLE4PH2LSB	0x65	FLT_BUCK2_CTRL	0x96	BUCK2_VOUTMAXMSB
0x2A	ADC_SAMPLE4TMSB	0x66	BUCK1_EA2	0x97	BUCK2_VOUTMAXLSB
0x2B	ADC_SAMPLE4TLSB	0x69	BUCK1_DCM	0x98	BUCK2_DVSCFG
0x2C	ADC_SAMPLE5MSB	0x6A	BUCK1_CFG3	0x99	BUCK2_DVSSEL
0x2D	ADC_SAMPLE5LSB	0x6E	BUCK1_PROTCFG	0x9A	BUCK2_RSPCFG1
0x2E	ADC_SAMPLE6MSB	0x72	BUCK1_DVS0CFG1	0x9B	BUCK2_RSPCFG0
0x2F	ADC_SAMPLE6LSB	0x73	BUCK1_DVS0CFG0	0x9C	BUCK2_EN_DLY
				0x9D	BUCK2_SHUTDN_DLY

Note: The registers not listed in the register map and RESERVED bits in the register map are reserved for factory use only. Changing these registers/bits can result in unexpected operation.

# **10. Register Description by Address**

Address	Bit	Name	R/W	Default	Description
IO_CHIPN	AME				
0x01	7:0	IO_CHIPNAME	R	0x02	Chip name. Set by Renesas 0x02 ISL91302B, dual/single output PMIC
IO_SOFT	RESE	  T			
0x0F	7:1	Reserved	N/A	0x00	Reserved
	0	IO_SOFTRESET	R/W	0x0	
					Reset all Registers And Reload from OTP
					0x0 Do nothing
					0x1 Reset all registers and reload from OTP
CHIPSTA	TE				
0x10	7	BG_BANDGAPOK	R	0x0	Dandson State
					Bandgap State       0x0     Bandgap outside of range
					0x1 Bandgap operating in proper range
	6	INTLDO_VDDOK	R	0x0	VDD state (for Both Apples And Digital LDOs and V )
					VDD state (for Both Analog And Digital LDOs and V <sub>BAT</sub> )       0x0     V <sub>BAT</sub> or Internal 1.5V outside of range
					0x0         VBAT of Internal 1.5V outside of range           0x1         VBAT and Internal 1.5V LDOs operating properly
	5	Reserved	R	0x0	Reserved
	4:2	BUCK1_PHASECOUNT	R	0x0	Number (Aufer Discus
					Number of Active Phases
					0x0 Disabled (power-down) 0x1 1
					0x2 2
					0x3 3
					0x4 4
					0x5 Reserved
					0x6 Reserved
					0x7 Reserved
	1.0	BUCK2_PHASECOUNT	R	0x0	
	1.0			0.00	Number of Active Phases
					0x0 Disabled (power-down)
					0x1 1
					0x2 2
					0x3 Reserved



Address	Bit	Name	R/W	Default	Description
CHIPSTA	TE_D	CMPGOOD			
0x11	7:4	Reserved	R	0x0	Reserved
	3	BUCK1_DCMSTATE	R	0x0	DCM/CCM State of Buck1       0x0     CCM       0x1     DCM
	2	BUCK2_DCMSTATE	R	0x0	DCM/CCM State of Buck2       0x0     CCM       0x1     DCM
	1	BUCK1_PGOODSTATE	R	0x0	Power-Good State for Buck1         0x0       Cleared when Buck1 is disabled or DAC set to 0V when BUCK1_PGOODDAC0V[0] = 0x0         0x1       Power is good (same signal as going to pin). Set after completion of first soft-start (delay controlled by BUCK1_PGOODDELAY[1:0])
	0	BUCK2_PGOODSTATE	R	0x0	Power-Good State for Buck2         0x0       Cleared when Buck2 is disabled or DAC set to 0V when BUCK2_PGOODDAC0V[0] = 0x0         0x1       Power is good (same signal as going to pin). Set after completion of first soft-start (delay controlled



Address	Bit	Name	R/W	Default	Description
FLT_REC	ORD	ТЕМР			
0x13	6:4	FLT_BOOT	R	0x0	BOOT Occurred         Read only, cleared when read         0x0       No boot process occurred since the last time this register was read         0x1       Boot process occurred (set high after OTP read is finished)         Reserved
	0.4 3	FLT_TEMPSDR	R	0x0	
	3	FLI_IEMPSUK	ĸ	UXU	Over-Temperature (OT) Shutdown (Rising Threshold)         Read only, cleared when read         0x0       No fault, less than threshold         0x1       Fault, greater than threshold
	2	FLT_TEMPWARNR	R	0x0	Over-Temperature (OT) Warning (Rising Threshold)         Read only, cleared when read         0x0       No fault, less than threshold         0x1       Fault, greater than threshold
	1	FLT_TEMPWARNF	R	0x0	Over-Temperature (OT) Warning (Falling Threshold) (Warning1 hysteresis)         Read only, cleared when read         0x0       No fault, less than threshold         0x1       Fault, greater than threshold
	0	FLT_TEMPSDF	R	0x0	Over-Temperature (OT) Shutdown (Falling Edge)         (Shutdown Hysteresis)         Read only, cleared when read         0x0       No fault, less than threshold         0x1       Fault, greater than threshold



Address	Bit	Name	R/W	Default	Description					
FLT_REC	ordi	BUCK1								
0x14	7	Reserved	R	0x0	Reserved					
	6	FLT_BUCK1_WOC	R	0x0						
					Way Overcurrent (WOC) for Buck1					
					Read only, cleared when read					
					0x0 No fault, less than threshold					
					0x1 Fault, greater than threshold					
	5	FLT_BUCK1_OV	R	0x0						
					Overvoltage (OV)					
					Read only, cleared when read					
					0x0 No fault, less than threshold					
					0x1 Fault, greater than threshold					
	4	FLT_BUCK1_UV	R	0x0						
					Undervoltage (UV)					
					Read only, cleared when read					
					0x0 No fault, greater than threshold					
					0x1 Fault, less than threshold					
	3	FLT_BUCK1_OCSDR	R	0x0	Overcurrent (OC) Shutdown (Rising Threshold) for Buck1					
					Read only, cleared when read					
					0x0 No fault, less than threshold					
					0x1 Fault, greater than threshold					
	2	FLT_BUCK1_OCWR	R	0x0	Overcurrent (OC) Warning (Rising Threshold) for Buck1					
					Read only, cleared when read					
					0x0 No fault, less then threshold					
					0x1 Fault, greater than threshold					
	1	FLT_BUCK1_OCWF	R	0x0						
					Overcurrent (OC) Warning (Falling Threshold) Buck1					
					Read only, cleared when read					
					0x0 No fault, less then threshold					
					0x1 Fault, greater than threshold					
	0	Reserved	R	0x0	Reserved					



BUCK2 Reserved FLT_BUCK2_WOC FLT_BUCK2_OV FLT_BUCK2_UV FLT_BUCK2_OCSDR FLT_BUCK2_OCWR FLT_BUCK2_OCWF Reserved OMSB ADC_SAMPLE0MSB	R R R R R R R R	0x0 0x0 0x0 0x0 0x0 0x0 0x0	See "FLT_RECORDBUCK1" Upper Byte of Temperature Sampl (Combine With LSB for 16-Bit Valu Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
FLT_BUCK2_WOC FLT_BUCK2_OV FLT_BUCK2_UV FLT_BUCK2_OCSDR FLT_BUCK2_OCWR FLT_BUCK2_OCWF Reserved 0MSB	R R R R R R R R	0x0 0x0 0x0 0x0 0x0 0x0 0x0	Upper Byte of Temperature Sampl (Combine With LSB for 16-Bit Valu Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
FLT_BUCK2_OV FLT_BUCK2_UV FLT_BUCK2_OCSDR FLT_BUCK2_OCWR FLT_BUCK2_OCWF Reserved 0MSB	R R R R R R	0x0 0x0 0x0 0x0 0x0 0x0	(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
FLT_BUCK2_UV FLT_BUCK2_OCSDR FLT_BUCK2_OCWR FLT_BUCK2_OCWF Reserved 0MSB	R R R R R	0x0 0x0 0x0 0x0 0x0	(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
FLT_BUCK2_OCSDR FLT_BUCK2_OCWR FLT_BUCK2_OCWF Reserved 0MSB	R R R R	0x0 0x0 0x0	(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
FLT_BUCK2_OCWR FLT_BUCK2_OCWF Reserved 0MSB	R R R	0x0 0x0	(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
FLT_BUCK2_OCWF Reserved 0MSB	R	0x0	(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
Reserved 0MSB	R		(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
OMSB		0x0	(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
1	R		(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
ADC_SAMPLE0MSB	R		(Combine With LSB for 16-Bit Value Source Range Format Units 0x0000	Temp. Sensor           ±200 °C           s.13.2           Temperature °C           0
			Range       Format       Units       0x0000	±200 °C s.13.2 Temperature °C 0
			Format Units 0x0000	s.13.2 Temperature °C 0
			Units 0x0000	Temperature °C 0
			0x0000	0
			0x0001	0.25
			0x0002	0.5
			0x0003	0.75
			0x0004	1
			0x0010	4
			0x0100	64
			0x0320	200
			0xFCE0	-200
			0xFCE1	-199.75
			0xFFFF	-0.25
1		I	1	
OLSB				combine with MSB for 16-bit value)
				0x0320 0xFCE0 0xFCE1  0xFFFF



Address	Bit	Name	R/W	Default	Des	cription
ADC_SA	MPLE	1PH1MSB				
0x18	7:0	ADC_SAMPLE1PH1MSB	R		Upper Byte of Buck1, Phase1 Ou (Combine with LSB for 16-Bit Val	
					Source	I <sub>SENSE</sub>
					Range	±8.192A
					Format	S13.2
					Units	Current (mA)
					0x0000	0
					0x0001	0.25
					0x0002	0.5
					0x0003	0.75
					0x0004	1
					0x0010	4
					0x0100	64
					0x7FFF	8191.75
					0x8000	-8192
					0x8001	-8191.75
					0xFFFF	-0.25
ADC_SA	MPLE	1PH1LSB				·
0x19		ADC_SAMPLE1PH1LSB	R		Lower byte of Buck1, Phase1 outpuvalue). See <u>"ADC_SAMPLE1PH1N</u>	ut current (combine with MSB for 16-bit <u>ISB"</u> for decode
ADC_SA	MPLE	1PH2MSB	1			
0x1A	7:0	ADC_SAMPLE1PH2MSB	R		Upper byte of Buck1, Phase2 outpu value). See <u>"ADC_SAMPLE1PH1M</u>	ut current (combine with LSB for 16-bit <u>ISB"</u> for decode
ADC_SA	MPLE	1PH2LSB		I		
0x1B	7:0	ADC_SAMPLE1PH2LSB	R		Lower byte of Buck1, Phase2 outpu value). See <u>"ADC_SAMPLE1PH1M</u>	ut current (combine with MSB for 16-bit <u>ISB"</u> for decode
ADC_SA	MPLE	1PH3MSB				
0x1C	7:0	ADC_SAMPLE1PH3MSB	R		Upper byte of Buck1, Phase3 outpu value). See <u>"ADC_SAMPLE1PH1M</u>	ut current (combine with LSB for 16-bit <u>ISB"</u> for decode
ADC_SA	MPLE	1PH3LSB				
0x1D	7:0	ADC_SAMPLE1PH3LSB	R		Lower byte of Buck1, Phase3 outpu value). See <u>"ADC_SAMPLE1PH1M</u>	ut current (combine with MSB for 16-bit I <mark>SB"</mark> for decode
ADC_SA	MPLE	1PH4MSB				
0x1E	7:0	ADC_SAMPLE1PH4MSB	R		Upper byte of Buck1, Phase4 outpu value). See <u>"ADC_SAMPLE1PH1M</u>	ut current (combine with LSB for 16-bit <u>ISB</u> <sup>*</sup> for decode
ADC_SA	MPLE	1PH4LSB	•	I		
0x1F	7:0	ADC_SAMPLE1PH4LSB	R		Lower byte of Buck1, Phase4 outpuvalue). See <u>"ADC_SAMPLE1PH1M</u>	ut current (combine with MSB for 16-bit <u>ISB"</u> for decode



Address	Bit	Name	R/W	Default	Des	scription
ADC_SA	<b>NPLE</b>	1TMSB	I			
0x20	7:0	ADC_SAMPLE1TMSB	R		Upper Byte of Buck1, Total Outp (Combine with LSB for 16-Bit Va	out Current Reading alue)
					Source	I <sub>SENSE</sub>
					Range	±32.768A
					Format	s.15
					Units	Current (mA)
					0x0000	0
					0x0001	1
					0x0002	2
					0x0003	3
					0x0004	4
					0x0010	16
					0x0100	256
					0x7FFF	32767
					0x8000	-32768
					0x8001	-32767
					0xFFFF	-1
	<b>NPLE</b>	1TLSB	I			
0x21	7:0	ADC_SAMPLE1TLSB	R		Lower byte of Buck1, total output of Buck1, total output of 16-bit value). See <u>"ADC_SAMPLE</u>	current reading (combine with MSB fo



Address	Bit	Name	R/W	Default	Des	scription
ADC_SAM	MPLE	2MSB	I			
0x22	7:0	ADC_SAMPLE2MSB	R		Upper Byte of Buck1, PVIN Sam (Combine with LSB for 16-Bit Va	
					Source	PVIN
					Range	±8.192V
					Format	s.13.2
					Units	Voltage (mV)
					0x0000	0
					0x0001	0.25
					0x0002	0.5
					0x0003	0.75
					0x0004	1
					0x0010	4
					0x0100	64
					0x7FFF	8191.75
					0x8000	-8192
					0x8001	-8191.75
					0xFFFF	-0.25
	MPLE	2LSB				
0x23	7:0	ADC_SAMPLE2LSB	R		Lower byte of Buck1 PVIN reading See <u>"ADC_SAMPLE2MSB"</u> for dec	(combine with MSB for 16-bit value).



Address	Bit	Name	R/W	Default	De	scription
ADC_SA	MPLE	3MSB				
0x24	7:0	ADC_SAMPLE3MSB	R		Upper Byte of Buck1, V <sub>OUT</sub> Sa (Combine with LSB for 16-Bit V	
					Source	V <sub>OUT</sub>
					Range	±8.192V
					Format	s.13.2
					Units	Voltage (mV)
					0x0000	0
					0x0001	0.25
					0x0002	0.5
					0x0003	0.75
					0x0004	1
					0x0010	4
					0x0100	64
					0x7FFF	8191.75
					0x8000	-8192
					0x8001	-8191.75
					0xFFFF	-0.25
ADC_SA	MPLE	3LSB				
0x25	7:0	ADC_SAMPLE3LSB	R		_ower byte of Buck1 V <sub>OUT</sub> reading See <u>"ADC_SAMPLE3MSB"</u> for de	g (combine with MSB for 16-bit value). code
ADC_SA	MPLE	4PH1MSB		I		
0x26	7:0	ADC_SAMPLE4PH1MSB	R		Upper byte of Buck2, Phase1 outp value). See <u>"ADC_SAMPLE1PH1</u>	but current (combine with LSB for 16-bit MSB" on page 47 for decode
ADC_SA	MPLE	4PH1LSB			· _	
0x27	7:0	ADC_SAMPLE4PH1LSB	R		_ower byte of Buck2, Phase1 outp value). See <u>"ADC_SAMPLE1PH1</u>	out current (combine with MSB for 16-bit <u>MSB" on page 47</u> for decode
ADC_SA	MPLE	4PH2MSB				
0x28	7:0	ADC_SAMPLE4PH2MSB	R		Upper byte of Buck2, Phase2 outp value). See <u>"ADC_SAMPLE1PH1</u>	out current (combine with LSB for 16-bit MSB" on page 47 for decode
ADC_SA	MPLE	4PH2LSB				
0x29	7:0	ADC_SAMPLE4PH2LSB	R		_ower byte of Buck2, Phase2 outp /alue). See <u>"ADC_SAMPLE1PH1</u>	out current (combine with MSB for 16-bit <u>MSB" on page 47</u> for decode
ADC_SA	MPLE	4TMSB		I		
0x2A	7:0	ADC_SAMPLE4TMSB	R		Upper byte of Buck2, total output over the second structure of the second stru	current (combine with LSB for 16-bit <u>B" on page 48</u> for decode
ADC_SA	MPLE	4TLSB				
0x2B	7:0	1	R		Lower byte of Buck2, total output ovalue). See "ADC_SAMPLE1TMS	current (combine with MSB for 16-bit B" on page 48 for decode



Address	Bit	Name	R/W	Default	De	scription
ADC_SAM	<b>I</b> PLE	5MSB				
0x2C	7:0	ADC_SAMPLE5MSB	R		Upper byte of Buck2, PVIN reading See <u>"ADC_SAMPLE2MSB" on particular sectors</u>	g (combine with LSB for 16-bit value). g <u>e 49</u> for decode
ADC_SAM	/IPLE	5LSB				
0x2D	7:0	ADC_SAMPLE5LSB	R		Lower byte of Buck2, PVIN reading See <u>"ADC_SAMPLE2MSB" on part</u>	g (combine with MSB for 16-bit value). <u>ge 49</u> for decode
ADC_SAM	/IPLE	6MSB				
0x2E	7:0	ADC_SAMPLE6MSB	R		Upper byte of Buck2, V <sub>OUT</sub> readin See <u>"ADC_SAMPLE3MSB" on part</u>	g (Combine with LSB for 16-bit value). <u>ge 50</u> for decode
ADC_SAM	/IPLE	6LSB		1	L	
0x2F	7:0	ADC_SAMPLE6LSB	R		Lower byte of Buck2, V <sub>OUT</sub> readin See <u>"ADC_SAMPLE3MSB" on part</u>	g (combine with MSB for 16-bit value). <u>ge 50</u> for decode.
ADC_AUX	(OMS	В				
0x30 7:0 ADC_AUX0MSB	R		value). Can be used in IO_PINMODE[3: external voltage with internal ADC	C.		
					Source	AUX0
					Range	±8.192V
					Format	s.13.2
					Units	Voltage (mV)
					0x0000 0x0001	0
					0x0002	0.23
					0x0003	0.75
					0x0004	1
					0x0010	4
					0x0100	64
					0x7FFF	8191.75
					0x8000	-8192
					0x8001	-8191.75
					0xFFFF	-0.25
ADC_AU)	KOLSI	3	1	I	1	
0x31	7:0	ADC_AUX0LSB	R		Lower byte of ADC auxiliary input see <u>"ADC_AUX0MSB"</u> for decode	#1 (combine with MSB for 16-bit value
ADC_AUX	(1MS	В				
0x32	7:0	ADC_AUX1MSB	R			#2 (combine with LSB for 16-bit value)   = 0xC, 0xD to measure external voltag <u>{0MSB</u> " for decode



Address	Bit	Name	R/W	Default	Description
ADC_AUX	(1LSI	B			
0x33	7:0	ADC_AUX1LSB	R		Lower byte of ADC auxiliary input #2 (combine with MSB for 16-bit value). See <u>"ADC_AUX0MSB"</u> for decode.
IO_SPICF	G				
0x43	7	IO_I2C_SPEED	R/W	0x0	I <sup>2</sup> C Speed Control         0x0       Low speed glitch and slew filters by default, high speed filters selectable by bus command.
					0x1 Glitch and slew filters set for high speed 3.4MHz mode.
	6	IO_SDA_SLEWFLTR	R/W	0x0	
					Transmit Slew Rate Control for I <sup>2</sup> C SDA
					0x0 Disables slew filtering.
					0x1 Enables slew filtering.
	5	IO_SPIRWPOL	R/W	0x0	
					R/W polarity
					0x0 R/W. 1 = Read, 0 = Write
					0x1 R/W. 1 = Write, 0 = Read
	4	IO_IRQ_CMOS	R/W	0x1	
					IRQ Type
					0x0 Open-drain output
					0x1 CMOS output
	3	IO_IRQ_INVERT	R/W	0x1	
					IRQ Polarity
					0x0 Active high
					0x1 Active low
	2	IO_SPICPOL	R/W	0x0	SPI Clock Polarity
					0x0 Active high
					0x1 Active low
	1	IO_SPICPHA	R/W	0x0	
				0,10	SPI Clock Phase
					0x0 Sample on the leading (first) clock edge. <b>Note:</b> Data must be stable for a half cycle before the first clock cycle
					0x1 Sample on the trailing (second) clock edge, regardless of whether that clock edge is rising or falling



Address	Bit	Name	R/W	Default	Description
	0	IO_SPIMODE	R/W	0x1	SPI Mode Selection           0x0         Byte Mode           Command Byte: R/W, AINC, 0x0, 0x0, 0x0, 0x0, 0x0, P1, P0           Address Byte: A7, A6, A5, A4, A3, A2, A1, A0           Data Byte: D7, D6, D5, D4, D3, D2, D1, D0           0x1         Byte Mode with Packet Length Field           Command Byte: R/W, AINC, 0x0, 0x0, 0x0, 0x0, P1, P0           Address Byte: A7, A6, A5, A4, A3, A2, A1, A0           Packet Length Byte: L7, L6, L5, L4, L3, L2, L1, L0           Data Byte: D7, D6, D5, D4, D3, D2, D1, D0
IO_MODE		L			
0x44	7	IO_BUCK1_EN	R/W	0x1	Enable for Buck1       0x0     Buck1 disabled       0x1     Buck1 enabled
	6	IO_BUCK2_EN	R/W	0x1	Enable for Buck2       0x0     Buck2 disabled       0x1     Buck2 enabled
	5:3	IO_MODECTRLRSVD	R	0x0	Reserved
	2	IO_ENVPPPULLDOWN	R/W	0x1	Enable for Weak Pull-Down on EN/VPP Pin         0x0       Weak pull-down disabled.         0x1       Weak pull-down enabled.
	1	RSVD	R/W	0x0	Reserved
	0	RSVD	R/W	0x0	Reserved



Address	Bit	Name	R/W	Default				Descript	on		
IO_RSTD	vs	•		•	•						
0x45	7:6	Reserved	R	0x0	N/A						
	5:4	IO_RSTDVS_CTRL	R/W	0x1					he control loc prresponding		this
					Bit [0]:	Buck1	0x0	) Do	Nothing		
							0x1	Re	set Buck1		
					Bit [1]:	Buck2	0x0	) Do	Nothing		
							0x1	Re	set Buck2		
	3	IO_NO_DVSSHUTDN	R/W	0x0				0 1 1			
							Power-Down		<u> </u>		
					0x0		r or pin is de		wer-down wh	ien the EN	
					0x1		e the automa r or pin is de		wer-down wl	hen the EN	l
	2:0	IO DEBOUNCETIME	R/W	0x0		•					
					Delay B	Before Sta	art Reset DV	S when the	WDOG_RS	T Pin is As	serted
							Delay	Time	Number of	f Clocks (3	32kHz)
							0µs		0		
					x1	1.56ms		50			
							3.125ms		100		
						0x3 6.25ms 0x4 12.5ms		200			
						x4 x5	9ms		400 288		
						x6	15.25ms		488		
						x7	14.5ms		464		
0x46	7:4	Reserved	R	0x0	Reserve	ed					
	3:0	IO_PINMODE	R/W	0x0							
					Pin Mode	MPIO0	MPIO1	MPIO2	MPIO3	GPIO0	GPIO1
					0x0	SCK	SS_B	MOSI	MISO	SCL	SDA
					0x1	SCK	SS_B	MOSI	MISO	EN_A	EN_B
					0x3	SCK	SS_B	MOSI	MISO	DVS1_0	DVS2_0
					0x4	DVS_ PIN1	DVS_ PIN0	PGOOD <sup>,</sup>	I PGOOD2	SCL	SDA
					0x5	DVS1_0	) DVS1_1	DVS2_0	_	SCL	SDA
					0x6	DVS1_0		PGOOD <sup>,</sup>	-	SCL	SDA
					0xD	ADC_IN	_	PGOOD	-	SCL	SDA
					0xE	ADC_IN		DVS_ PIN1	DVS_ PIN0	SCL	SDA
									own is Rese ation" on pag		should not



Address	Bit	Name	R/W	Default	Description
ADC_RAT	ECC	MDCM			
	ECC		R/W	Default 0x3	Sampling period when either one of the buck outputs is in CCM.0x0Off or One-shot Mode0x131.25µs0x262.5µs0x3125µs0x4250µs0x5500µs0x61ms0x72ms0x84ms0x98ms0xA16ms0xB32ms
	3:0	ADC_RATEDCM	R/W	0x5	0xC       64ms         0xD       128ms         0xE       256ms         0xF       512ms             Sampling period when both buck outputs are in DCM.         0x0       Off or One-shot Mode         0x1       31.25µs
					0x2       62.5µs         0x3       125µs         0x4       250µs         0x5       500µs         0x6       1ms         0x7       2ms         0x8       4ms         0x9       8ms         0xA       16ms         0xB       32ms         0xC       64ms         0xD       128ms         0xE       256ms
					0xF 512ms



Address	Bit	Name	R/W	Default	Description
ADC_RAT	EIDL	E			
0x51	7	ADC_SEQUENCER_ DISABLE	R/W	0x0	0x0 = Enable the ADC conversion sequence. 0x1 = Disable the ADC conversion sequence.
	6	ADC_ONE_SHOT_MODE	R/W	0x0	0x0 = Normal operation 0x1 = Trigger a one-shot ADC conversion
	5:4	RESERVED	R/W	0x1	Internal use only, do not modify these bits.
	-	ADC_RATEIDLE	R/W	0x6	Sampling period when both buck outputs are disabled.         0x0       Off or One-shot Mode         0x1       31.25µs         0x2       62.5µs         0x4       250µs         0x5       500µs         0x6       1ms         0x7       2ms         0x8       4ms         0x9       8ms         0xA       16ms         0xA       128ms
					0xE         256ms           0xF         512ms



Address	Bit	Name	R/W	Default	Description				
ADC_TEM	<b>NPCF</b>	G	I						
0x52	7	ADC_TEMPCCM	R/W	0x1	0x0 = Temperature measurement is disabled when either one of the buc outputs is in CCM. 0x1 = Temperature measurement in enabled when either one of the buc outputs is in CCM.				
	6	ADC_TEMPDCM	R/W	in DCM. 0x1 = Temperature measurement is enabled when both buck outputs DCM.					
	5	ADC_TEMPIDLE	R/W						
	4:3	RESERVED	R	0x0					
	3:0	ADC_TEMPIIR	R/W	0x6					
					Temperature IIR coefficient.				
					0x0 1				
					0x1 1/2				
					0x2 1/4				
					0x3 1/8				
					0x4 1/16				
					0x5 1/32				
					0x6 1/64				
					0x7 1/128				



Address	Bit	Name	R/W	Default			Description				
ADC_BUG	CK1C	FG									
0x53	7	ADC_BUCK1CCM	R/W	0x1		, ,		when Buck1 is in CCM when Buck1 is in CCM			
	6	ADC_BUCK1DCM	R/W	0x0	0x0 = Disable IOUT, PVIN, VOUT measurements when Buck1 is in DCM 0x1 = Enable IOUT, PVIN, VOUT measurements when Buck1 is in DCM						
	5	ADC_BUCK1IDLE	R/W	0x0	0x0 = Disable IOUT, PVIN, VOUT measurements when Buck1 is idle (disabled) 0x1 = Enable IOUT, PVIN, VOUT measurements when Buck1 is idle (disabled)						
	4	ADC_BUCK1MASKVOUT	R	0x0	x0 0x0 = Do not mask (enable) Buck1 VOUT measurement 0x1 = Mask (disable) Buck1 VOUT measurement						
	3	RESERVED	R	0x0							
2	2:0	ADC_BUCK1IIR	R/W	0x2	Buck1 III	R coefficients.					
						IOUT IIR	PVIN IIR	VOUT IIR			
					0x0	1	1	1			
					0x1	1/2	1	1			
					0x2	1/2	1/2	1/2			
					0x3	1/2	1/4	1/4			
					0x4	1/4	1	1			
					0x5	1/4	1/2	1/2			
					0x6	1/4	1/4	1/4			
					0x7	1/16	1/16	1/16			
								<u>.</u>			



Address	Bit	Name	R/W	Default			Description					
ADC_BUG	CK2C	FG			•							
0x54	7	ADC_BUCK2CCM	R/W	0x1		, ,		when Buck2 is in CCM when Buck2 is in CCM				
	6	ADC_BUCK2DCM	R/W	0x0	0x0 = Disable IOUT, PVIN, VOUT measurements when Buck2 is in DCM 0x1 = Enable IOUT, PVIN, VOUT measurements when Buck2 is in DCM							
	5	ADC_BUCK2IDLE	R/W	0x0	0x0 = Disable IOUT, PVIN, VOUT measurements when Buck2 is idle (disabled) 0x1 = Enable IOUT, PVIN, VOUT measurements when Buck2 is idle (disabled)							
	4	ADC_BUCK2MASKVOUT	R	0x0	0 0x0 = Do not mask (enable) Buck2 VOUT measurement 0x1 = Mask (disable) Buck2 VOUT measurement							
	3	RESERVED	R	0x0								
2	2:0	ADC_BUCK2IIR	R/W	0x2	Buck2 IIR coefficients.							
						IOUT IIR	PVIN IIR	VOUT IIR				
					0x0	1	1	1				
					0x1	1/2	1	1				
					0x2	1/2	1/2	1/2				
					0x3	1/2	1/4	1/4				
					0x4	1/4	1	1				
					0x5	1/4	1/2	1/2				
					0x6	1/4	1/4	1/4				
					0x7	1/16	1/16	1/16				
						1,10						



Address	Bit	Name	R/W	Default	Description
ADC_AUX	(RAT	ECFG			
0x55	7	ADC_AUX0IIR16	R/W	0x0	AUX0 input IIR coefficient setting: 0x0 = Coefficient is set to 1. 0x1 = Coefficient is set to 1/16.
	6	ADC_AUX0MASK	R/W	0x1	0x0 = AUX0 input measurement is not masked (Enabled). 0x1 = AUX0 input measurement is masked (Disabled).
	5	ADC_AUX1IIR16	R/W	0x0	AUX1 input IIR coefficient setting: 0x0 = Coefficient is set to 1. 0x1 = Coefficient is set to 1/16.
	4	ADC_AUX1MASK	R/W	0x1	0x0 = AUX1 input measurement is not masked (Enabled). 0x1 = AUX1 input measurement is masked (Disabled).
	3:0	ADC_AUXRATE	R/W	0x0	Sampling period for AUX0 and AUX1 inputs.
					0x0 Off
					0x1 31.25µs
					0x2 62.5µs
					0x3 125µs
					0x4 250µs
					0x5 500µs
					0x6 1ms
					0x7 2ms
					0x8 4ms
					0x9 8ms
					0xA 16ms
					0xB 32ms
					0xC 64ms
					0xD 128ms
					0xE 256ms
					0xF 512ms
FLT_TEM				OVEE	
0x58	7.0	FLT_TEMPWARN	R/W	0x55	Temperature warning threshold (highest)
					°C = FLT_TEMPWARN[7:0] (Range 0°C to +255°C)
					0x00 0
					0x01 1
					0x7F 127
			1		0x80 128
			1		0x81 129
			1		
			1		0x8C 140
					0xFF 255



Address	Bit	Name	R/W	Default	Description			
FLT_TEM	PSHL	JTDN						
0x59	7:0	FLT_TEMPSHUTDN	R/W	0x8C				
					Tempera	ature shutdown threshold (highest)		
						°C = FLT_TEMPSHUTDN[7:0] (Range 0°C to +255°C)		
					0x00	0		
					0x01	1		
					0x7F	127		
					0x80	128		
					0x81	129		
					0x8C	140		
					0xFF	255		



Address	Bit	Name	R/W	Default	Description
FLT_TEM	PHYS	5			
0x5A	7:4	FLT_TEMPWARNHYS	R/W	0x5	Temperature warning hysteresis
					Cooling trigger °C = FLT_TEMPWARN[7:0] – ((2 x FLT_TEMPHYS[7:4])+2) Note: Cooling trigger must be ≥ 0°C
				Hysteresis °C	
				0x0 2	
					0x1 4
					0x7 16
					0x8 18
			0x9 20		
					0xF 32
	3:0	FLT_TEMPSHUTDNHYS	R/W	V 0xE	Temperature shutdown hysteresis
					Cooling trigger         °C = FLT_TEMPSHUTDN[7:0] – ((2 x FLT_TEMPHYS[3:0])+2)         Note: Cooling trigger must be ≥ 0°C
					Hysteresis °C
					0x0 4
					0x1 8
					0x7 32
					0x8 36
					0x9 40
			0xF 64		



Address	Bit	Name	R/W	Default		Description			
FLT_BUC	K1_I8	SENSEWARN	•						
0x5B	7:4	FLT_BUCK1_	R/W	0x5	-				
		ISENSEWARNR				current sense warning rising threshold			
					Note: H	esis mA = $512mA \times (FLT_BUCK1_ISENSEAWARNR-FLT_BUCK1_ISENSEAWARNF)$ Hysteresis must be $\geq 0mA$ and small enough to ensure that the goes below the falling threshold.			
						Current (mA) = 512mA x FLT_BUCK1_ISENSEWARNR			
			0x0 0		0				
					0x1 510				
					0x4	2048			
				0xF	8160				
	3:0	FLT_BUCK1_ ISENSEWARNF	R/W	N 0x4	Buck1 current sense warning falling threshold				
						Current (mA) = 510mA x FLT_BUCK1_ISENSEWARNF			
					0x0	0			
					0x1	510			
					 0x4	2048			
					0xF	8160			
FLT_BUC	K2_IS	SENSEWARN			•				
0x5C	7:4	FLT_BUCK2_ ISENSEWARNR	R/W	0x5		urrent sense warning rising threshold. <u>FBUCK1_ISENSEWARN</u> for decode			
	3:0	FLT_BUCK2_ ISENSEWARNF	R/W	0x4		urrent sense warning falling threshold. [_ <u>BUCK1_ISENSEWARN"</u> for decode			



Address	Bit	Name	R/W	Default		Description	
FLT_BUC	K1_I	SENSESHUTDN					
0x5D	7:0	FLT_BUCK1_ ISENSESHUTDN	R/W	0xE0	Buck1	current sense shutdown threshold (highest)	
						Hysteresis is accomplished by shutting down the Buck and ng the filtered I <sub>SENSE</sub> value.	
						Current (mA) = 32mA x FLT_BUCK1_ISENSESHUTDN[7:0]	
					0x00	0	
					0x01	32 x Nph	
						0x7F	4064 x Nph
						0x80	4096 x Nph
					0x81	4128 x Nph	
					0xA0	5120 x Nph	
					0xFF	8160 x Nph (from ENCF)	
FLT_BUC	K2_I	SENSESHUTDN		<u> </u>	<u> </u>		
0x5E	7:0	FLT_BUCK2_ ISENSESHUTDN	R/W	0xE0		urrent sense shutdown threshold (highest). T_BUCK1_ISENSESHUTDN" for decode	



Address	Bit	Name	R/W	Default	Description
FLT_MAS	KTE	MP			·
0x60	7	FLT_MASKBOOT	R/W	0x0	
					Mask IRQ for FLT_BOOT
					0x0 IRQ passed to output pin
					0x1 IQ masked from output pin
	6:4	Reserved	R	0x0	Reserved
	3	FLT_MASKTEMPSDR	R/W	0x0	
					Mask IRQ for FLT_TEMPSDR
					0x0 IRQ passed to output pin
					0x1 IRQ masked from output pin
	2	FLT_MASKTEMPWARNR	R/W	0x0	Mask IRQ for FLT_TEMPWARNR
					0x0 IRQ passed to output pin. Note: FLT_MASKTEMPWARNF must also be set to 0x0 or the IRQ clears itself when the temperature drops below the falling threshold
					0x1 IRQ masked from output pin
	1	FLT MASKTEMPWARNF	R/W	0x0	
		_			Mask IRQ for FLT_TEMPWARNF
					0x0 IRQ passed to output pin. Note: FLT_MASKTEMPWARNR must also be set to 0x0 or the IRQ clears itself when the temperature goes above the rising threshold
					0x1 IRQ masked from output pin
	0	FLT_MASKTEMPSDF	R/W	0x0	
					Mask IRQ for FLT_TEMPSDF
					0x0 IRQ passed to output pin
					0x1 IQ masked from output pin



Address	Bit	Name	R/W	Default	Description
FLT_MAS	KBU	CK1			
0x61	7	Reserved	R	0x0	Reserved
	6	FLT_BUCK1_MASKWOC	R/W	0x0	
					Mask IRQ for FLT_BUCK1_WOC
					0x0 IRQ passed to output pin
					0x1 IRQ masked from output pin
	5	FLT_BUCK1_MASKOV	R/W	0x0	
					Mask IRQ for FLT_BUCK1_OV
					0x0 IRQ passed to output pin
					0x1 IRQ masked from output pin
	4	FLT_BUCK1_MASKUV	R/W	0x0	
					Mask IRQ for FLT_BUCK1_UV
					0x0 IRQ passed to output pin
					0x1 IRQ masked from output pin
	3	FLT_BUCK1_MASKOCSDR	R/W	0x0	
					Mask IRQ for FLT_BUCK1_OCSDR 0x0 IRQ passed to output pin
					0x1 IRQ masked from output pin
	2	FLT_BUCK1_MASKOCWR	R/W	0x0	Mask IRQ for FLT_BUCK1_OCWR
					0x0 IRQ passed to output pin.
					<b>Note:</b> FLT_MASKOCWF must also be set to 0x0 or the IRQ clears itself when the current drops below the falling threshold
					0x1 IRQ masked from output pin
	1	FLT_BUCK1_MASKOCWF	R/W	0x0	
				0,10	Mask IRQ for FLT_BUCK1_OCWF
					0x0 IRQ passed to output pin
					0x1 IRQ masked from output pin
	0	Reserved	R	0x0	Reserved



Address	Bit	Name	R/W	Default			Description	
FLT_MAS	KBU	СК2						
0x62	7	FLT_BUCK2_MASKRSVD1	R	0x0		asks for Buck		
	6	FLT_BUCK2_MASKWOC	R/W	0x0	See <u>"F</u>	LT_MASKBU	ICK1" for description	
	5	FLT_BUCK2_MASKOV	R/W	0x0				
	4	FLT_BUCK2_MASKUV	R/W	0x0				
	3	FLT_BUCK2_MASKOCSDR	R/W	0x0				
	2	FLT_BUCK2_MASKOCWR	R/W	0x0				
	1	FLT_BUCK2_MASKOCWF	R/W	0x0				
	0	FLT_BUCK2_MASKRSVD2	R	0x0				
FLT_OT_	CTRL							
0x63	7:2	Reserved	R	0x0	Reser	ved		
	1:0	FLT_CTRLOT	R/W	0x3	<b>D</b> :	о. т.		
					Bit	'	rature (OT) fault response	
					<0>	0×0	Buck1 shuts down on Over-Temperature (OT) detection faults, measured by the ADC. (FLT_TEMPSDR[0] = $0x0 \rightarrow 0x1$ ) Buck is re-enabled when the temperature measured by the ADC drops below the hysteresis level (FLT_TEMPSDF[0] = $0x1\rightarrow 0x0$ )	
						0x1	Buck1 does not shut down on Over-Temperature (OT) faults	
					<0>	0x0	Buck2 OT control. See description above.	
						0x1		



Address	Bit	Name	R/W	Default	Description
FLT_BUC	K1_C	TRL			•
0x64	7:5	Reserved	R	0x0	Reserved
	4	FLT_BUCK1_CTRLOC	R/W	0x0	
					Overcurrent (OC) fault response
					0x0 The buck shuts down on Overcurrent (OC) detection faults, measured by the ADC (FLT_OCSDR[0] = $0x0 \rightarrow 0x1$ ). The overcurrent detection fault state can only be cleared by cycling the EN pin or by issuing a soft-reset command. (IO_SOFTRESET[0] = $0x1$ )
					$\begin{array}{ c c c c c } 0x1 & The buck does not shut down on Overcurrent (OC) detection faults, measured by the ADC. \\ (FLT_OCSDR[0] = 0x0 \rightarrow 0x1) \end{array}$
	3	FLT_BUCK1_CTRLWOC	R/W	0x0	Way Overcurrent (WOC) fault response
					0x0 The buck shuts down on Way Overcurrent (WOC) detection
					faults, measured by the buck (FLT_WOC[0] = $0x0 \rightarrow 0x1$ ). The buck is quickly re-enabled using the same register configuration. If the fault still exists, the buck shuts down (and restarts) until the fault is removed
					$ \begin{array}{ c c c c } \hline 0x1 & The buck does not shut down on Way Overcurrent (WOC) \\ detection faults, measured by the buck \\ (FLT_WOC[0] = 0x0 \rightarrow 0x1) \end{array} $
	2:1	FLT_BUCK1_CTRLOV	R/W	0x2	Overvoltage (OV) fault response
					0x0/The buck crowbars the output driver (turns on the NMOS) on0x2Overvoltage (OV) detection faults, measured by the buck (FLT_OV[0] = $0x0 \rightarrow 0x1$ ).After 32 to 64 µs, the buck shuts down and exits crowbar mode. The buck is quickly re-enabled using the same configuration. If the fault still exists the buck shuts down (and restarts) until the fault is removed
	0	FLT_BUCK1_CTRLUV	R/W	0x0	Undervoltage (UV) Fault Response
					0x0 Buck will shut down on Undervoltage (UV) detection faults,
					measured by the buck. (FLT_UV[0] = $0x0 \rightarrow 0x1$ )0x1Buck will not shut down on Undervoltage (UV) detection faults, measured by the buck. (FLT_UV[0] = $0x0 \rightarrow 0x1$ )
FLT_BUC				00	Duck of fault control
0x65	7:5	FLT_BUCK2_CTRLRSVD	R	0x0	Buck2 fault control. See <u>"FLT_BUCK1_CTRL"</u> for description
	4	FLT_BUCK2_CTRLOC	R/W	0x0	
	3	FLT_BUCK2_CTRLWOC	R/W	0x0	4
	2:1	FLT_BUCK2_CTRLOV	R/W	0x2	4
	0	FLT_BUCK2_CTRLUV	R/W	0x0	



Address	Bit	Name	R/W	Default		Description			
BUCK1_E	A2								
0x66	7:6	BUCK1_VOUTFBDIV	R/W	0x0					
					BUCK1_ VOUTFBDIV[1:0]	Feedback Divider Ratio (FBDIV)	Maximum V <sub>OUT</sub> Setting		
					0x0	1.0	1.2328V		
					0x1	0.8	1.5410V		
					0x2	0.6	2.0547V		
					0x3	Reserved	Reserved		
		Reserved	R	0x1B	Reserved				
BUCK1_C	ОСМ								
0x69	7:3	Reserved	R	0x0	Reserved				
2	2	BUCK1_FCCM	R/W	0x0	Forced Continuous Conduction Mode (CCM)				
					0x0	0x0 Discontinuous Conduction Mode (DCM) allowed when load reaches 0A			
					0x1	Always operates in CCM			
	1:0	Reserved	R/W	0x0	Reserved				
BUCK1_C	FG3				I				
0x6A	7:6	BUCK1_FSEL	R/W	0x2					
					Buck's steady-state swi	tching frequency			
					0x0	2MHz			
					0x1	3MHz			
					0x2	4MHz			
					0x3	Reserve	d		
	5:4	Reserved	R	0x2	Reserved				
	3:0	Reserved	R	0x1 0x2 0x3	Reserved <b>Note:</b> Default = 0x1 for 2	2+2, 0x2 for 3+1, and 0x3 for	4+0 configurations		



Address	Bit	Name	R/W	Default			Desc	cription	
BUCK1_F	ROT	CFG		II					
0x6E	7:4	Reserved	R	0x0	Reserved	ł			
	3	BUCK1_ENUVOV	R/W	0x1	Underv	oltage (UV) a	and Overvoltag	e (OV) compara	tors of V <sub>OUT</sub>
					0x0	Disabled			
					0x1	DAC[9:0] out of the	value reaches buck is held lo	w even though t	voltage (OV) signal
	2	BUCK1_OVNOHYS	R/W	0x1					
					Hystere	sis on the O	vervoltage (OV	) comparator of	V <sub>OUT</sub>
					0x0	Hysteresis OV flag go target		/ <sub>OUT</sub> decreases	below the DAC
				0x1	Hysteresis OV flag go offset (offs	bes low when \	/ <sub>OUT</sub> goes below JCK1_UVOVTH[	/ DAC target + 1:0]).	
	1:0	BUCK1_UVOVTH	R/W	0x2					
					UV and	OV trip thre	sholds of V <sub>OUT</sub>		
					0x0	±150mV \	window around	DAC target	
					0x1	±200mV \	window around	DAC target	
					0x2 ±250mV window around DAC target				
					0x3	±300mV v	window around	DAC target	
BUCK1_	DVS00	CFG1							
0x72	7:0	BUCK1_DVS0VOUT92	R/W	Trim to 0.6V		eight bits of a		0] value to gene	rate V <sub>OUT</sub> for
					FBDIV i			above 0.3V. 0.8x, 0.6x. Refe	r to formula in
					FBDIV	1.0	0.8	0.6	
					DAC	V <sub>OUT</sub> (V)	V <sub>OUT</sub> (V)	V <sub>OUT</sub> (V)	
					0x000	0.0000	0.0000	0.0000	
					0x001	0.0012	0.0015	0.0020	
					0x200	0.6170	0.7713	1.0283	
					0x201	0.6182	0.7728	1.0303	
	1	1	1	1					1 1



Address	Bit	Name	R/W	Default	Description
BUCK1_C	OVS00	CFG0			
0x73	7:6	BUCK1_DVS0VOUT10	R/W	Trim to 0.6V	Lower two bits of a 10-bit DAC[9:0] value to generate V <sub>OUT</sub> for DVS Configuration 0. <b>Note:</b> When DVS Configuration 0 is selected (from pins or registers) any write to BUCK1_DVS0CFG0 causes DVS ramping to occur
	5	BUCK1_DVS0DECAY	R/W	0x0	Buck DECAY for DVS configuration 0
					0x0 Active pull-down, decay determined by selected slew rate
					0x1 Decay mode (load determines slew rate)
	4:0	Reserved	R	0x0	Reserved bits
BUCK1_C	VS10	CFG1			
0x74	7:0	BUCK1_DVS1VOUT92	R/W	0xBF	Buck1 DVS1 Configuration 1. See <u>"BUCK1_DVS0CFG1"</u> for description
BUCK1_C	VS10	CFG0		1	
0x75	7:6	BUCK1_DVS1VOUT10	R/W	0x3	Buck1 DVS1 Configuration 0. See <u>"BUCK1_DVS0CFG0"</u> for description
	5	BUCK1_DVS1DECAY	R/W	0x0	
	4:0	BUCK1_DVS1RSVD	R	0x0	
BUCK1_D	VS20	CFG1			
0x76	7:0	BUCK1_DVS2VOUT92	R/W	0x58	Buck1 DVS2 Configuration 1. See <u>"BUCK1_DVS0CFG1"</u> for description
BUCK1_C	OVS20	CFG0			
0x77	7:6	BUCK1_DVS2VOUT10	R/W	0x0	Buck1 DVS2 Configuration 0. See <u>"BUCK1_DVS0CFG0"</u> for description
	5	BUCK1_DVS2DECAY	R/W	0x0	
	4:0	BUCK1_DVS2RSVD	R	0x0	
BUCK1_C	VS30	CFG1			
0x78	7:0	BUCK1_DVS3VOUT92	R/W	0x00	Buck1 DVS3 Configuration 1. See <u>"BUCK1_DVS0CFG1"</u> for description
BUCK1_C	VS30	CFG0			
0x79	7:6	BUCK1_DVS3VOUT10	R/W	0x0	Buck1 DVS3 Configuration 0. See <u>"BUCK1_DVS0CFG0"</u> for description
	5	BUCK1_DVS3DECAY	R/W	0x0	
	4:0	BUCK1_DVS3RSVD	R	0x0	
BUCK1_V	OUT	MAXMSB			
0x7A	7:2	Reserved	R	0x00	Reserved
	1:0	BUCK1_VOUTMAX98	R/W	0x3	
					Upper two bits of V <sub>OUT</sub> maximum programming limit
					Data format is same as BUCK1_DVS[3:0]VOUT[9:0]
BUCK1_V	/OUT	MAXLSB			·
0x7B	7:0	BUCK1_VOUTMAXLSB	R/W	0xFF	
					Lower eight bits of V <sub>OUT</sub> maximum programming limit
					Data format is same as BUCK1_DVS[3:0]VOUT[9:0]



Address	Bit	Name	R/W	Default		Description			
BUCK1_D	ovsc	FG							
0x7C	7:5	Reserved	R	0x0	Reserve	ed			
	4	BUCK1_PGOODDAC0V	R/W	0x0	Power-	Good state when Buck1 DAC is set to 0V	,		
					0x0	BUCK1 PGOOD is set low when the	DAC is set to 0V		
					0x1 BUCK1_PGOOD is allowed to stay high when the DAC is set to 0V				
	3:2 BUCK1 PGOODDELAY R/W 0x0								
		_			Delay before the PGOOD signal is set (no delay		when cleared)		
						Delay = BUCK1_PGOODDELAY[1:0] /32kHz (μs)	Number of Clocks		
					0x0	0	0		
				0x1	125	4			
					0x2	375	12		
					0x3	1000	32		
	1:0	BUCK1_DVSPIN_CTRL	R/W	0x0					
					Registe	er determines whether Buck1 follows glob	al DVS pins		
					Bit<0>				
					0x0 BUCK1_DVSSELECT[0] does NOT follow DVS_PIN0.				
					0x1	BUCK1_DVSSELECT[0] mirrors DVS_P	INO.		
					Bit<1>				
					0x0	BUCK1_DVSSELECT[1] does NOT follo	w DVS_PIN1.		
					0x1	BUCK1_DVSSELECT[1] mirrors DVS_P	IN1.		
						namic Voltage Scaling (DVS)" on page 2 sing this register. This register is valid onl			



Address	Bit	Name	R/W	Default				Description		
BUCK1_C	vss	EL								
0x7D	7:3	Reserved	R	0x00	Reserve	əd				
	2	BUCK1_DVSCTRL	R/W	0x0	-					
					BUCK	1 DVS cont	irol			
					0x0	Use BUC configurat	_	ELECT[1:0] to select the active DVS		
					0x1	Use DVS	pin(s) to co	ontrol the DVS selection		
						DVS_1	DVS_0	Active DVS configuration registers		
						0	0	Use DVS0 voltage setting		
						0	1	Use DVS1 voltage setting		
						1	0	Use DVS2 voltage setting		
				1	1	Use DVS3 voltage setting				
						<u>/namic Volt</u> sing this re		ig (DVS)" on page 23 for more information		
	1:0	BUCK1_DVSSELECT	R/W	0x0	BUCK	1 DVS sele	ction			
						0x0	Use [	DVS0 voltage setting		
						0x1	Use D	DVS1 voltage setting		
						0x2	Use E	DVS2 voltage setting		
						0x3	Use D	DVS3 voltage setting		
								TRL[0] = 0x0 any write to the register DVS ramping event to occur.		
						See <u>"Dynamic Voltage Scaling (DVS)" on page 23</u> for more informat about using this register				



Address	Bit	Name	R/W	Default		Des	scription			
BUCK1_F	SPC	FG1								
0x7E	7	BUCK1_RSPCFG1RSVD1	R	0x0	Reserved					
	6:4	BUCK1_RSPUP	R/W	0x7	This slew rate is us voltage.	sed when the cur	rrent voltage is le	ess than the target		
					V <sub>OUT</sub> ramp slew rate. RSP = BUCK1_RSPUP[1:0], ramp speed FBDIV = BUCK1_VOUTFBDIV[1:0] = (1.0, 0.8, 0.6) Slow = BUCK1_RSPUP[2] = 0 Fast = BUCK1_RSPUP[2] = 1					
							V <sub>OUT</sub> Ramp	Speed mV/µs		
					RSP	FBDIV	Fast	Slow		
					0x0	1.0	12	3		
					0x1	1.0	24	6		
					0x2	1.0	57.6	14.4		
					0x3	1.0	115.2	28.8		
							V <sub>OUT</sub> Ramp	Speed mV/µs		
					RSP	FBDIV	Fast	Slow		
					0x0 0x2	0.8/0.6	12	3		
					0x1 0x3	0.8/0.6	24	6		
	3	Reserved	R	0x0	Reserved					
	2:0	BUCK1_RSPDN	R/W	0x3	This slew rate is used when the current voltage is greater than the voltage. See <u>BUCK1_RSPUP</u> for decode information					



Address	Bit	Name	R/W	Default			Description		
BUCK1_F	SPC	FG0		ı					
0x7F	7	Reserved	R	0x0	Reserved				
	6:4	BUCK1_RSPPUP	R/W	0x7	This slew rate is used when the current voltage is 0V and the target is greater than 0V.				
	V <sub>OUT</sub> Ramp Slew Rate RSP = BUCK1_RSPPUP[1:0], ramp s FBDIV = BUCK1_VOUTFBDIV[1:0] = (7 Slow = BUCK1_RSPPUP[2] = 0 Fast = BUCK1_RSPPUP[2] = 1							3, 0.6)	
							V <sub>OUT</sub> Ramp Speed mV/μs		
					RSP	FBDIV	/ Fast	Slow	
					0x0	1.0	6	1.2	
					0x1	1.0	12	3	
					0x2	1.0	28.8	7.2	
					0x3	1.0	57.6	14.4	
							V <sub>OUT</sub> Ramp	Speed mV/µs	
					RSP	FBDIV	Fast	Slow	
					0x0 0x2	0.8/0.6	5 12	3	
					0x1 0x3	0.8/0.6	6 24	6	
	3	BUCK1_RSPCFG0RSVD0	R	0x0	Reserved			LJ	
	2:0	BUCK1_RSPPDN[2:0]	R/W	0x3	This slew rate is used when the current voltage is greater than 0V and target voltage is 0V. See <u>BUCK1_RSPUP</u> bit descriptions for decode information.				
ВИСК1_Е	N_DI	_Y							
0x80	7:6	Reserved	R	0x0	Reserved				
	5:0	BUCK1_EN_DLY	R/W	0x00	Delay time from BUCK1_EN and IO_REGVAID going high to Buck actually ramping up. Delay = (integer value of register) ms [1ms/LSB]				
					Delay				
					0x00	0			
					0x01	1m	าร		
					0x02	2m	าร		
					0x3F	63	ms		
BUCK1_S	ниті	DN_DLY		<u> </u>					
0x81	7:6	Reserved	R	0x0	Reserved	rved			
	5:0	BUCK1_SHUTDN_DLY	R/W	0x00	Delay time from BUCK1_EN and IO_REGVAID going low to Buck1 V <sub>OUT</sub> actually ramping down. Delay = (integer value of register) ms [1ms/LSB] See <u>"BUCK1_EN_DLY"</u> for description				



Address	Bit	Name	R/W	Default	Description	
BUCK2_E	A2					
0x82	7:6	BUCK2_VOUTFBDIV	R/W	0x0	Buck2 FBDIV configuration. See "BUCK1_EA2" on page 69 for description	
	5:0	Reserved	R	0x1B	Reserved	
BUCK2_C	СМ			1		
0x85	7:3	Reserved	R	0x0	Reserved	
	2	BUCK2_FCCM	R/W	0x0	Buck2 DCM configuration. See <u>"BUCK1_DCM" on page 69</u> for description	
	1:0	Reserved	R	0x0	Reserved	
BUCK2_C	FG3					
0x86	7:6	BUCK2_FSEL	R	0x2	Buck's steady state frequency. See <u>"BUCK1_CFG3" on page 69</u> for description	
	5:4	Reserved	R/W	0x2	Reserved	
	3:0	Reserved	R	0x0 0x1	Reserved Note: Default = 0x0 for 3+1, 0x1 for 2+2 configuration, N/A for 4+0	
BUCK2_F	ROT	CFG		•		
0x8A	7:4	Reserved	R	0x0	See <u>"BUCK1_PROTCFG" on page 70</u>	
	3	BUCK2_ENUVOV	R/W	0x1		
	2	BUCK2_OVNOHYS	R/W	0x1		
	1:0	BUCK2_UVOVTH	R/W	0x2		
BUCK2_C	VS00	CFG1		I		
0x8E	7:0	BUCK2_DVS0VOUT92	R/W	0xFF	See <u>"BUCK1_DVS0CFG1" on page 70</u>	
BUCK2_C	VS00	CFG0		•		
0x8F	7:6	BUCK2_DVS0VOUT10	R/W	0x3	See <u>"BUCK1_DVS0CFG0" on page 71</u>	
	5	BUCK2_DVS0DECAY	R/W	0x0		
	4:0	Reserved	R	0x0		
BUCK2_C	VS10	CFG1				
0x90	7:0	BUCK2_DVS1VOUT92	R/W	0xBF	See <u>"BUCK1_DVS0CFG1" on page 70</u>	
BUCK2_C	VS10	CFG0				
0x91	7:6	BUCK2_DVS1VOUT10	R/W	0x3	See <u>"BUCK1_DVS0CFG0" on page 71</u>	
	5	BUCK2_DVS1DECAY	R/W	0x0		
	4:0	Reserved	R	0x0		
BUCK2_C	VS20	CFG1				
0x92	7:0	BUCK2_DVS2VOUT92[7:0]	R/W	0x58	See <u>"BUCK1_DVS0CFG1" on page 70</u>	
BUCK2_C	VS20	CFG0				
0x93	7:6	BUCK2_DVS2VOUT10	R/W	0x0	See <u>"BUCK1_DVS0CFG0" on page 71</u>	
	5	BUCK2_DVS2DECAY	R/W	0x0		
	4:0	Reserved	R	0x0		
BUCK2_C	VS30	CFG1				
0x94	7:0	BUCK2_DVS3VOUT92	R/W	0x00	See <u>"BUCK1_DVS0CFG1" on page 70</u>	
BUCK2_C	VS30	CFG0	•			
0x95	7:6	BUCK2_DVS3VOUT10	R/W	0x0	See <u>"BUCK1_DVS0CFG0" on page 71</u>	
	5	BUCK2_DVS3DECAY	R/W	0x0		
	4:0	Reserved	R	0x0		



Address	Bit	Name	R/W	Default	Description
BUCK2_V	Όυτι	MAXMSB			
0x96	7:2	Reserved	R	0x00	Reserved
-	1:0	BUCK2_VOUTMAX98[1:0]	R/W	0x3	
					Upper 2 bits of V <sub>OUT</sub> Maximum Programming Limit
					Data format is same as BUCK2_DVS[3:0]VOUT[9:0]
BUCK2_V	Όυτι	MAXLSB			
0x97	7:0	BUCK2_VOUTMAXLSB[7:0]	R/W	0xFF	
					Lower byte of V <sub>OUT</sub> Maximum Programming Limit
					Data format is same as BUCK2_DVS[3:0]VOUT[9:0]
BUCK2_D	vsci	FG	l		
0x98	7:5	Reserved	R	0x0	See <u>"BUCK1_DVSCFG" on page 72</u>
	4	BUCK2_PGOODDAC0V	R/W	0x0	
	3:2	BUCK2_PGOODDELAY	R/W	0x0	
	1:0	BUCK2_DVSPIN_CTRL	R/W	0x0	
BUCK2_D	VSSI	EL			
0x99	7:3	Reserved	R	0x00	See <u>"BUCK1_DVSSEL" on page 73</u>
	2	BUCK2_DVSCTRL	R/W	0x0	
	1:0	BUCK2_DVSSELECT	R/W	0x0	
BUCK2_R	SPC	FG1			
0x9A	7	Reserved	R	0x0	See <u>"BUCK1_RSPCFG1" on page 74</u>
	6:4	BUCK2_RSPUP	R/W	0x7	
	3	Reserved	R	0x0	
	2:0	BUCK2_RSPDN[2:0]	R/W	0x3	
BUCK2_R	SPC	FG0			
0x9B	7	Reserved	R	0x0	See <u>"BUCK1_RSPCFG0" on page 75</u>
	6:4	BUCK2_RSPPUP[2:0]	R/W	0x7	
	3	Reserved	R	0x0	
	2:0	BUCK2_RSPPDN[2:0]	R/W	0x3	
BUCK2_E	N_DI	Y			
0x9C	7:6	Reserved	R	0x0	See <u>"BUCK1_EN_DLY" on page 75</u>
	5:0	BUCK2_EN_DLY	R/W	0x00	
BUCK2_S	ниті	DN_DLY			
0x9D	7:6	Reserved	R	0x0	See <u>"BUCK1_SHUTDN_DLY</u> " on page 75
	5:0	BUCK2_SHUTDN_DLY	R/W	0x00	



# 11. Revision History

Rev.	Date	Description
3.01	Feb 2, 2022	Removed Related Literature section. Updated Ordering Information table formatting. Updated Table 2 to show pinmode 0x2 and 0xF options, and mark as reserved. Clarify and correct temperature ratings and conditions in the Thermal Information, Recommended Operation Conditions, and Analog Specifications sections. Fixed incorrect IC part number in the Dynamic Voltage Scaling (DVS) and Power Sequencing sections. Added Eq.1 for 10-bit DAC to V <sub>OUT</sub> transfer function and removed Table 12. Updated and added numerous registers and details to Register Address Map and Register Description by Address sections. Added FBDIV settings to the description table for 0x66[7:6]. Corrected Table of V <sub>OUT</sub> voltages in register 0x72. Updated ADC Telemetry section.
3.00	Feb 20, 2020	Updated Typical App Circuits. Added Note 1 to Ordering Information table. Updated Figure titles for Figures 16-11. Updated Figures 19, 20, 36, 38. Updated Table 12. Added the following sentence to section 7.1 on page 30: "The ISL91302B does not support SPI reads on the MISO bus when using multiple slave devices on the same bus." Removed registers 0x78 (BUCK1_DVS3CFG1), and 0x82 (BUCK2EA2) and added registers 0x78 (BUCK2_DCM) and 0x86 (BUCK_CFG3) to Register Address Map on page 40. Added descriptions for registers BUCK1_DCM, BUCK1_CFG3, BUCK2_DCM, BUCK2_CFG3, ADC_BUCK1CFG, and ADC_BUCK2CFG to section 10, Register Descriptions. Updated disclaimer.
2.00	Apr 5, 2018	Updated Figures 3-5: INT (output) WDOG_RST (Input) Updated Note 2. Updated Parameter from "PVIN to GND" to "PVIN to PGND" on page 10. Updated the test condition for CCM Frequency Tolerance from 3MHz to 4MHz on page 12. Updated Figures 24 and 26.
1.00	Feb 28, 2018	Updated Title Updated Figure 1 Added Table 1 on page 6. Updated the Analog Specifications Conditions in table heading. Added Buck Output Voltage Range, and Output Voltage Step Size for BUCKx_VOUTFBDIV[1:0] = 0x00, BUCKx_VOUTFBDIV[1:0] = 0x01, BUCKx_VOUTFBDIV[1:0] = 0x02 in Spec table on page 11. Added High-Side and Low-Side Switch On-Resistance specs on page 12. Updated Table 5. Updated Figure 30. Updated Data Hold Time minimum specifications for all modes in Table 18 on page 35 (changed from 0ns to 15ns). Updated IO_CHIPNAME description on page 41. Updated FLT_RECORDBUCK2 Bits 1, 3, 5 names on page 44. Added Default information for FLT_OT_CTRL on page 61 and BUCK1_RSPCFG1 on page 67. Updated description for BUCK1_DVS0CFG1 on page 64 (changed 0.4V to 0.3V). Removed About Intersil section. Updated disclaimer.
0.00	Sep 22, 2017	Initial release



# 12. Package Outline Drawing

For the most recent package outline drawing, see W6x9.54.

#### W6x9.54

54 Ball Wafer Level Chip Scale Package (WLCSP 0.4mm PITCH) Rev 0, 10/15



TYPICAL RECOMMENDED LAND PATTERN

#### NOTES:

- 1. All dimensions are in millimeters.
- 2. Dimensions and tolerance per ASME Y 14.5M 1994.

2 Primary datum and seating plane are defined by the spherical crowns of the bump.

- 4. Dimension is measured at the maximum bump diameter parallel to primary datum
- 5. Bump position designation per JESD 95-1, SPP-010.

ANSMD refers to non-solder mask defined pad design per TB451.



0.500 ±0.050

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SIDE VIEW

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